



# 1200.2 SSD

SAS Product Manual

## High Endurance models

### Standard drives

ST400FM0323  
ST200FM0133

### Self-Encrypting drives

ST400FM0333  
ST200FM0143

### Scalable Endurance models

### Standard drives

ST3840FM0043  
ST1920FM0043

### Self-Encrypting drives

ST3840FM0053  
ST1920FM0053

## Mainstream Endurance models

### Standard drives

ST3200FM0023  
ST1600FM0003  
ST800FM0173  
ST400FM0233

### Self-Encrypting drives

ST3200FM0033  
ST1600FM0013  
ST800FM0183  
ST400FM0243

### SED FIPS 140-2 Models (Review Pending)

ST3200FM0043  
ST1600FM0023  
ST800FM0213  
ST400FM0293

## Light Endurance models

### Standard drives

ST3840FM0003  
ST3200FM0063  
ST1920FM0003  
ST1600FM0073  
ST960FM0003  
ST800FM0233  
ST480FM0003  
ST400FM0303

### Self-Encrypting drives

ST3840FM0023  
ST3200FM0073  
ST1920FM0023  
ST1600FM0083  
ST960FM0013  
ST800FM0243  
ST480FM0013  
ST400FM0343

100773817, Rev. B.

April 2016

## Document Revision History

Revision	Date	Pages affected and description of changes
Rev. B	4/7/2016	<ul style="list-style-type: none"><li>Updated Model Numbers in <i>Section 2.1, Regulatory Model Numbers on page 8.</i></li><li>Updated values in <i>Section 6.1, Power specifications on page 29.</i></li><li>Updated all figures in <i>Section 6.2.2, Drive Performance Based on Power Setting on page 37.</i></li><li>Updated <i>Table 13, Mainstream Endurance 2.5" model DC power requirements on page 35.</i></li></ul>
Rev. A	09/29/2015	Initial release.

© 2016 Seagate Technology LLC. All rights reserved.

Publication number: 100773817, Rev. B. April 2016

Seagate, Seagate Technology and the Spiral logo are registered trademarks of Seagate Technology LLC in the United States and/or other countries. SeaTools is either a trademark or registered trademark of Seagate Technology LLC or one of its affiliated companies in the United States and/or other countries. The FIPS logo is a certification mark of NIST, which does not imply product endorsement by NIST, the U.S., or Canadian governments. All other trademarks or registered trademarks are the property of their respective owners.

No part of this publication may be reproduced in any form without written permission of Seagate Technology LLC.

Call 877-PUB-TEK1 (877-782-8351) to request permission.

When referring to drive capacity, one gigabyte, or GB, equals one billion bytes and one terabyte, or TB, equals one trillion bytes. Your computer's operating system may use a different standard of measurement and report a lower capacity. In addition, some of the listed capacity is used for formatting and other functions, and thus will not be available for data storage. Actual quantities will vary based on various factors, including file size, file format, features and application software. Actual data rates may vary depending on operating environment and other factors. The export or re-export of hardware or software containing encryption may be regulated by the U.S. Department of Commerce, Bureau of Industry and Security (for more information, visit [www.bis.doc.gov](http://www.bis.doc.gov)), and controlled for import and use outside of the U.S. Seagate reserves the right to change, without notice, product offerings or specifications.

---

<b>Seagate® Technology Support Services</b> .....	<b>6</b>
---	----------

---

<b>1.0 Scope</b> .....	<b>7</b>
------------------------	----------

---

<b>2.0 Applicable standards and reference documentation</b> .....	<b>8</b>
2.1 Regulatory Model Numbers .....	8
2.2 Standards .....	8
2.2.1 Electromagnetic compatibility .....	8
2.2.2 Electromagnetic compliance .....	9
2.2.3 European Union Restriction of Hazardous Substances (RoHS) .....	9
2.2.4 China Restriction of Hazardous Substances (RoHS) Directive .....	10
2.3 Reference documents .....	10

---

<b>3.0 General description</b> .....	<b>11</b>
3.1 Standard features .....	11
3.2 Performance .....	11
3.3 Media description .....	12
3.4 Warranty .....	12
3.5 Formatted capacities .....	12
3.6 Programmable drive capacity .....	13
3.7 Factory-installed options .....	13
3.8 Thin Provisioning .....	14
3.8.1 Logical Block Provisioning .....	14
3.8.2 Thin Provisioning capabilities .....	14
3.8.3 UNMAP .....	14
3.8.4 FORMAT UNIT command .....	14
3.8.5 Protection Information (PI) and Security (SED) .....	15

---

<b>4.0 Performance characteristics</b> .....	<b>16</b>
4.1 Internal drive characteristics .....	16
4.2 Performance characteristics .....	16
4.2.1 Response time .....	16
4.2.2 FORMAT UNIT command execution time for 512-byte LBA's (minutes) .....	17
4.2.3 Performance .....	18
4.3 Start/stop time .....	19
4.4 Cache control .....	20
4.4.1 Caching write data .....	20
4.4.2 Prefetch operation .....	20

---

<b>5.0 Reliability specifications</b> .....	<b>21</b>
5.1 Error rates .....	23
5.1.1 Unrecoverable Errors .....	23
5.1.2 Interface errors .....	23
5.2 Endurance Management .....	23
5.2.1 Wear Leveling .....	23
5.2.2 Garbage Collection .....	23
5.2.3 Write Amplification .....	23
5.2.4 UNMAP .....	23
5.2.5 Data Retention .....	24
5.2.6 SSD Percentage Used Endurance Indicator .....	24
5.3 Reliability and service .....	24
5.3.1 Annualized Failure Rate (AFR) and Mean Time Between Failure (MTBF) .....	24

# Contents

5.3.2	Preventive maintenance .....	24
5.3.3	Hot plugging the drive .....	24
5.3.4	S.M.A.R.T. ....	25
5.3.5	Thermal monitor .....	26
5.3.6	Drive Self Test (DST) .....	26
5.3.7	Product warranty .....	28
<hr/>		
<b>6.0</b>	<b>Physical/electrical specifications .....</b>	<b>29</b>
6.1	Power specifications .....	29
6.1.1	Conducted noise immunity .....	29
6.1.2	Power sequencing .....	29
6.2	Power consumption .....	30
6.2.1	Direct Current Consumption by Voltage Rail .....	30
6.2.2	Drive Performance Based on Power Setting .....	37
6.2.3	Current profiles .....	44
6.3	Environmental limits .....	47
6.3.1	Temperature .....	47
6.3.2	Relative humidity .....	48
6.3.3	Effective altitude (sea level) .....	48
6.3.4	Shock and vibration .....	48
6.3.5	Air cleanliness .....	50
6.3.6	Corrosive environment .....	50
6.3.7	Electromagnetic susceptibility .....	50
6.4	Mechanical specifications .....	51
<hr/>		
<b>7.0</b>	<b>About FIPS .....</b>	<b>53</b>
7.1	Purpose .....	53
7.2	Validation Program .....	53
7.3	Seagate Enterprise SED .....	53
7.4	Security Level 2 .....	54
<hr/>		
<b>8.0</b>	<b>About self-encrypting drives .....</b>	<b>55</b>
8.1	Data encryption .....	55
8.2	Controlled access .....	55
8.2.1	Admin SP .....	55
8.2.2	Locking SP .....	55
8.2.3	Default password .....	55
8.3	Random number generator (RNG) .....	55
8.4	Drive locking .....	56
8.5	Data bands .....	56
8.6	Cryptographic erase .....	56
8.7	Authenticated firmware download .....	57
8.8	Power requirements .....	57
8.9	Supported commands .....	57
8.10	Sanitize - Cryptographic Erase .....	57
8.11	RevertSP .....	57
<hr/>		
<b>9.0</b>	<b>Defect and error management .....</b>	<b>58</b>
9.1	Drive internal defects/errors .....	58
9.2	Drive error recovery procedures .....	59
9.3	SAS system errors .....	59
9.4	Auto-Reallocation .....	59
9.5	Protection Information (PI) .....	59

# Contents

9.5.1	Levels of Pl. ....	60
9.5.2	Setting and determining the current Type Level ....	60
9.5.3	Identifying a Protection Information drive ....	60
<hr/>		
<b>10.0</b>	<b>Installation .....</b>	<b>61</b>
10.1	Drive orientation .....	61
10.2	Cooling .....	61
10.3	Drive mounting .....	62
10.4	Grounding .....	63
<hr/>		
<b>11.0</b>	<b>Interface requirements .....</b>	<b>64</b>
11.1	SAS features .....	64
11.1.1	Task management functions .....	64
11.1.2	Task management responses .....	64
11.2	Dual port support .....	64
11.3	SCSI commands supported .....	65
11.3.1	INQUIRY data .....	70
11.3.2	MODE SENSE data .....	71
11.4	Miscellaneous operating features and conditions .....	73
11.4.1	SAS physical interface .....	73
11.4.2	Physical characteristics .....	76
11.4.3	Connector requirements .....	76
11.4.4	Electrical description .....	76
11.4.5	Pin descriptions .....	76
11.4.6	SAS transmitters and receivers .....	77
11.4.7	Power .....	77
11.5	Signal characteristics .....	77
11.5.1	Ready LED Out .....	77
11.5.2	Differential signals .....	78
11.6	SAS-3 Specification compliance .....	78
11.7	Additional information .....	78

---

Figure 1.	3200GB Mainstream Endurance: Performance vs Power Limit Settings IOPs chart.....	37
Figure 2.	1600GB Mainstream Endurance: Performance vs Power Limit Settings IOPs chart.....	37
Figure 3.	800GB Mainstream Endurance: Performance vs Power Limit Settings IOPs chart.....	38
Figure 4.	400GB Mainstream Endurance: Performance vs Power Limit Settings IOPs chart.....	38
Figure 5.	3200GB Light Endurance: Performance vs Power Limit Settings IOPs chart .....	39
Figure 6.	1600GB Light Endurance: Performance vs Power Limit Settings IOPs chart .....	39
Figure 7.	800GB Light Endurance: Performance vs Power Limit Settings IOPs chart .....	40
Figure 8.	400GB Light Endurance: Performance vs Power Limit Settings IOPs chart .....	40
Figure 9.	3840GB Light Endurance: Performance vs Power Limit Settings IOPs chart .....	41
Figure 10.	1920GB Light Endurance: Performance vs Power Limit Settings IOPs chart .....	41
Figure 11.	960GB Light Endurance: Performance vs Power Limit Settings IOPs chart .....	42
Figure 12.	480GB Light Endurance: Performance vs Power Limit Settings IOPs chart .....	42
Figure 13.	3840GB Scalable Endurance: Performance vs Power Limit Settings IOPs chart .....	43
Figure 14.	1920GB Scalable Endurance: Performance vs Power Limit Settings IOPs chart .....	43
Figure 15.	Current profiles for 800GB standard and 400GB High Endurance models.....	44
Figure 16.	Current profiles for 400GB standard and 200GB high endurance models.....	45
Figure 17.	Current profiles for 200GB standard and 100GB high endurance models.....	46
Figure 18.	Recommended mounting .....	49
Figure 19.	Mounting configuration dimensions (2.5" - 7mm models) .....	51
Figure 20.	Mounting configuration dimensions (2.5" - 15mm models) .....	52
Figure 21.	Example of FIPS tamper evidence labels.....	54
Figure 22.	Physical interface .....	61
Figure 23.	Air flow .....	62
Figure 24.	Physical interface .....	73
Figure 25.	SAS device plug dimensions.....	74
Figure 26.	SAS device plug dimensions (detail) .....	75
Figure 27.	SAS transmitters and receivers.....	77

# Seagate® Technology Support Services

For information regarding online support and services, visit: <http://www.seagate.com/contacts/>

For information regarding Warranty Support, visit: <http://www.seagate.com/support/warranty-and-replacements/>

For information regarding data recovery services, visit: <http://www.seagate.com/services-software/seagate-recovery-services/recover/>

For Seagate OEM, Distribution partner portal and reseller portal, visit: <http://www.seagate.com/partners/>

## 1.0 Scope

This manual describes Seagate® 1200.2 SAS SSD (Serial Attached SCSI) drives.

Seagate 1200.2 SAS SSD drives support the SAS Protocol specifications to the extent described in this manual. The *SAS Interface Manual* (part number 100293071) describes the general SAS characteristics of this and other Seagate SAS drives. The Self-Encrypting Drive Reference Manual, part number 100515636, describes the interface, general operation, and security features available on Self-Encrypting Drive models.

Product data communicated in this manual is specific only to the model numbers listed in this manual. The data listed in this manual may not be predictive of future generation specifications or requirements. If designing a system which will use one of the models listed or future generation products and need further assistance, please contact the Field Applications Engineer (FAE) or our global support services group. See “Seagate® Technology Support Services” on page 6

Unless otherwise stated, the information in this manual applies to standard Secure Download and Diagnostic (SD&D) and Self-Encrypting Drive models.

High Endurance		Scalable Endurance	
Standard	Self-Encrypting	Standard	Self-Encrypting
ST400FM0323	ST400FM0343	ST3840FM0043	ST3840FM0053
ST200FM0133	ST200FM0143	ST1920FM0043	ST1920FM0053

Mainstream Endurance		
Standard	Self-Encrypting	SED FIPS 140-2
ST3200FM0023	ST3200FM0033	ST3200FM0043
ST1600FM0003	ST1600FM0013	ST1600FM0023
ST800FM0173	ST800FM0183	ST800FM0213
ST400FM0233	ST400FM0243	ST400FM0293

Light Endurance			
Standard	Self-Encrypting	Standard	Self-Encrypting
ST3840FM0003	ST3840FM0023	ST960FM0003	ST960FM0013
ST3200FM0063	ST3200FM0073	ST800FM0233	ST800FM0243
ST1920FM0003	ST1920FM0023	ST480FM0003	ST480FM0013
ST1600FM0073	ST1600FM0083	ST400FM0303	ST400FM0343

**Note.** Previous generations of Seagate Self-Encrypting Drive models were called Full Disk Encryption (FDE) models before a differentiation between drive-based encryption and other forms of encryption was necessary.

**Note.** The Self-Encrypting Drive models indicated on the cover of this product manual have provisions for “Security of Data at Rest” based on the standards defined by the Trusted Computing Group (see [www.trustedcomputinggroup.org](http://www.trustedcomputinggroup.org)).

For more information on FIPS 140-2 Level 2 certification see Section 7.0 on page 53.

For product certification status visit - <http://csrc.nist.gov/groups/STM/cmvp/documents/140-1/1401vend.htm>.



## 2.0 Applicable standards and reference documentation

The drives documented in this manual have been developed as system peripherals to the highest standards of design and construction. The drives depend on host equipment to provide adequate power and environment for optimum performance and compliance with applicable industry and governmental regulations. Special attention must be given in the areas of safety, power distribution, shielding, audible noise control, and temperature regulation. In particular, the drives must be securely mounted to guarantee the specified performance characteristics. Mounting by bottom holes must meet the requirements of Section 10.3.

### 2.1 Regulatory Model Numbers

The following model numbers represent the indicated form factors and features of all configurations within the series:

#### Regulatory Models as Documented in the Declaration of Conformity (DoC):

- STR004 - (represents drive size 2.5 inch x 15mm height)
- STR005 - (represents drive size 2.5 inch x 7mm height)

### 2.2 Standards

The Seagate 1200.2 SAS SSD family complies with Seagate standards as noted in the appropriate sections of this manual and the Seagate *SAS Interface Manual*, part number 100293071.

The drives are recognized in accordance with UL 60950-1, EN60950-1 and IEC 60950-1. Product also fulfills the requirements of IEC 62368-1.

The security features of Self-Encrypting Drive models are based on the "TCG Storage Architecture Core Specification" and the "TCG Storage Workgroup Security Subsystem Class: Enterprise\_A" specification with additional vendor-unique features as noted in this product manual.

#### 2.2.1 Electromagnetic compatibility

The drive, as delivered, is designed for system integration and installation into a suitable enclosure prior to use. The drive is supplied as a subassembly and is not subject to Subpart B of Part 15 of the FCC Rules and Regulations.

The design characteristics of the drive serve to minimize radiation when installed in an enclosure that provides reasonable shielding. The drive is capable of meeting the Class B limits of the FCC Rules and Regulations of the Canadian Department of Communications when properly packaged; however, it is the user's responsibility to assure that the drive meets the appropriate EMI requirements in their system. Shielded I/O cables may be required if the enclosure does not provide adequate shielding. If the I/O cables are external to the enclosure, shielded cables should be used, with the shields grounded to the enclosure and to the host controller.

##### 2.2.1.1 Electromagnetic susceptibility

The drive as delivered is tested to meet susceptibility requirements in a representative enclosure. It is the responsibility of those integrating the drive within their systems to perform those tests required and design their system to ensure that equipment operating in the same system as the drive or external to the system does not adversely affect the performance of the drive. See Section 6.2.1, DC power requirements.

### **2.2.2 Electromagnetic compliance**

Seagate uses an independent laboratory to confirm compliance with all applicable EMC directives/standards. The drive was tested in a representative system for typical applications and comply with the Electromagnetic Interference/Electromagnetic Susceptibility (EMI/EMS) for Class B products. The selected system represents the most popular characteristics for test platforms.

Although the test system with this Seagate model complies with the directives/standards, we cannot guarantee that all systems will comply. The computer manufacturer or system integrator shall confirm EMC compliance and provide the appropriate marking for their product.

#### **Electromagnetic compliance for the European Union**

If this model has the CE Marking it complies with the European Union requirements of the Electromagnetic Compatibility.

#### **Australian RCM**

If this model has the RCM Marking it complies with the Australia/New Zealand Standard AS/NZ CISPR22 and meets the Electromagnetic Compatibility (EMC) Framework requirements of the Australian Communications and Media Authority (ACMA).

#### **Canada ICES-003**

If this model has the ICES-003 Marking it complies with the Canadian Standard Association Standard CAN/CSA-CISPR 22- 10, Information Technology Equipment - Radio Disturbance Characteristics - Limits and Methods of Measurement.

#### **Korean KCC**

If these drives have the Korean Communications Commission (KCC) logo, they comply with KN22 and KN24.

#### **Taiwanese BSMI**

If this model has the Taiwanese certification mark then it complies with Chinese National Standard, CNS13438.

### **2.2.3 European Union Restriction of Hazardous Substances (RoHS)**

The European Union Restriction of Hazardous Substances (RoHS) Directive restricts the presence of chemical substances, including Lead (Pb), in electronic products effective July 2006.

A number of parts and materials in Seagate products are procured from external suppliers. We rely on the representations of our suppliers regarding the presence of RoHS substances in these parts and materials. Our supplier contracts require compliance with our chemical substance restrictions, and our suppliers document their compliance with our requirements by providing material content declarations for all parts and materials for the disk drives documented in this publication. Current supplier declarations include disclosure of the inclusion of any RoHS-regulated substance in such parts or materials.

Seagate also has internal systems in place to ensure ongoing compliance with the RoHS Directive and all laws and regulations which restrict chemical content in electronic products. These systems include standard operating procedures that ensure that restricted substances are not utilized in our manufacturing operations, laboratory analytical validation testing, and an internal auditing process to ensure that all standard operating procedures are complied with.

## 2.2.4 China Restriction of Hazardous Substances (RoHS) Directive 中国限制危险物品的指令

This product has an Environmental Protection Use Period (EPUP) of 20 years. The following table contains information mandated by China's "Marking Requirements for Control of Pollution Caused by Electronic Information Products" Standard.



该产品具有20年的环境保护使用周期（EPUP）。下表包含了中国“电子产品所导致的污染的控制的记号要求”所指定的信息。

Name of Parts 部件名称	Toxic or Hazardous Substances or Elements 有毒有害物质或元素					
	Lead 铅 (Pb)	Mercury 汞 (Hg)	Cadmium 镉 (Cd)	Hexavalent Chromium 六价铬 (Cr6+)	Polybrominated Diphenyl 多溴联苯 (PBB)	Polybrominated Diphenyl Ether 多溴二苯醚 (PBDE)
PCBA	X	0	0	0	0	0
Chassis	X	0	0	0	0	0

"O" indicates the hazardous and toxic substance content of the part (at the homogeneous material level) is lower than the threshold defined by the China RoHS MCV Standard.

“O”表示该部件（于同类物品程度上）所含的危险和有毒物质低于中国RoHS MCV标准所定义的门槛值。

"X" indicates the hazardous and toxic substance content of the part (at the homogeneous material level) is over the threshold defined by the China RoHS MCV Standard.

“X”表示该部件（于同类物品程度上）所含的危险和有毒物质超出中国RoHS MCV标准所定义的门槛值。

## 2.3 Reference documents

SCSI Commands Reference Manual	Seagate part number: 100293068
SAS Interface Manual	Seagate part number: 100293071
ANSI SAS Documents	
SFF-8144	54mm x 78.5mm Form Factor with micro serial connector
SFF-8223	2.5" Drive Form Factor with Serial Connector
SFF-8460	HSS Backplane Design Guidelines
SFF-8470	Multi Lane Copper Connector
SFF-8482	SAS Plug Connector
ANSI INCITS.xxx	Serial Attached SCSI (SAS-3) Standard (T10/2212-D)
ISO/IEC 14776-xxx	SCSI Architecture Model-5 (SAM-5) Standard (T10/2104-D)
ISO/IEC 14776-xxx	SCSI Primary Commands-4 (SPC-4) Standard (T10/1731-D)
ISO/IEC 14776-xxx	SCSI Block Commands-3 (SBC-3) Standard (T10/1799-D)
ANSI Small Computer System Interface (SCSI) Documents	
X3.270-1996	(SCSI-3) Architecture Model
Trusted Computing Group (TCG) Documents (apply to Self-Encrypting Drive models only)	
TCG Storage Architecture Core Specification, Rev. 1.0	
TCG Storage Security Subsystem Class Enterprise Specification, Rev. 1.0	
Self-Encrypting Drives Reference Manual	Seagate part number: 100515636

In case of conflict between this document and any referenced document, this document takes precedence.

### 3.0 General description

Seagate 1200.2 SAS SSD drives provide high performance, high capacity data storage for a variety of systems with a Serial Attached SCSI (SAS) interface. The Serial Attached SCSI interface is designed to meet next-generation computing demands for performance, scalability, flexibility and high-density storage requirements.

Seagate 1200.2 SAS SSD drives are random access storage devices designed to support the Serial Attached SCSI Protocol as described in the ANSI specifications, this document, and the *SAS Interface Manual* (part number 100293071) which describes the general interface characteristics of this drive. Seagate 1200.2 SAS SSD drives are classified as intelligent peripherals and provide level 2 conformance (highest level) with the ANSI SCSI-1 standard. The SAS connectors, cables and electrical interface are compatible with Serial ATA (SATA), giving future users the choice of populating their systems with either SAS or SATA drives. This allows users to continue to leverage existing investment in SCSI while gaining a 12Gb/s serial data transfer rate.

The Self-Encrypting Drive models indicated on the cover of this product manual have provisions for “Security of Data at Rest” based on the standards defined by the Trusted Computing Group (see [www.trustedcomputinggroup.org](http://www.trustedcomputinggroup.org)).

**Note.** Never disassemble and do not attempt to service items in the enclosure.  
The drive does not contain user-replaceable parts. Opening for any reason voids the drive warranty.

#### 3.1 Standard features

1200.2 SSD drives have the following standard features:

- 3.0 / 6.0 / 12.0 Gb Serial Attached SCSI (SAS) interface
- Integrated dual port SAS controller supporting the SCSI protocol
- Support for SAS expanders and fanout adapters
- 128 - deep task set (queue)
- Supports up to 16 initiators
- Jumperless configuration
- User-selectable logical block size (512, 520, 524, 528, 4096, 4160, 4192, or 4224 bytes per logical block)
- Industry standard SFF 2.5-inch dimensions
- ECC and Micro-RAID Error Recovery
- No preventive maintenance or adjustments required
- Self diagnostics performed when power is applied to the drive
- Vertical, horizontal, or top down mounting
- Drive Self Test (DST)
- Power loss data protection
- Thin Provisioning with Block Unmap Support

1200.2 SSD Self-Encrypting Drive models have the following additional features:

- Automatic data encryption/decryption
- Controlled access
- Random number generator
- Drive locking
- Up to 16 independent data bands
- Cryptographic erase of user data for a drive that will be repurposed or scrapped
- Authenticated firmware download
- SANITIZE command support

#### 3.2 Performance

- Firmware controlled multi-segmentable cache buffer
- Up to 1900MB/s maximum instantaneous data transfers on dual 12Gb capable configurations.
- Background processing of queue
- Non-Volatile Write Cache

**Note.** There is no significant performance difference between Self-Encrypting Drive and standard (non-Self-Encrypting Drive) models.

### 3.3 Media description

**Note.** The media used on the drive consists of Enterprise (grade) Multi Layer Cell (eMLC) NAND Flash for improved reliability and performance.

### 3.4 Warranty

Consult a Seagate sales representative for warranty terms and conditions.

### 3.5 Formatted capacities

Standard OEM models are formatted to 512 bytes per block. The block size is selectable at format time. Supported block sizes are 512, 520, 524, 528, 4096, 4160, 4192, and 4224. Users having the necessary equipment may modify the data block size before issuing a format command and obtain different formatted capacities than those listed.

To provide a stable target capacity environment and at the same time provide users with flexibility if they choose, Seagate recommends product planning in one of two modes:

Seagate designs specify capacity points at certain block sizes that Seagate guarantees current and future products will meet. We recommend customers use this capacity in their project planning, as it ensures a stable operating point with backward and forward compatibility from generation to generation. The current guaranteed operating points for this product are shown below. The Capacity stated is identical when the drive is formatted with or without PI enabled.

**Note.** PI not available in combination with 524 and 528 byte block sizes.

**Table 1 Formatted Capacity Block Count (3.2TB, 1.6TB 800GB & 400GB models)**

Capacity (Blocks)						
Block Size	3840GB		3200GB		1920GB	
	Decimal	Hex	Decimal	Hex	Decimal	Hex
<b>512</b>	7,501,476,528	1BF1F72B0	6,251,233,968	1749A42B0h	3,750,748,848	DF8FE2B0
<b>520</b>	7,342,769,280	1B5A9C480	6,118,974,384	16CB823B0h	3,671,384,640	DAD4E240
<b>524</b>	7,244,899,840	1AFD46600	6,037,416,536	167DBAA58h	3,622,449,920	D7EA3300
<b>528</b>	7,140,797,184	1A99FEB00	5,950,664,304	162AFEE70h	3,570,398,592	D4CFF580
<b>4096</b>	937,684,566	37E3EE56	781,404,246	2E934856h	468,843,606	1BF1FC56
<b>4160</b>	919,384,616	36CCB228	766,153,848	2DAA9478	459,692,312	1B665918
<b>4192</b>	907,786,264	361BB818	756,488,552	2D171968h	453,893,136	1B0DDC10
<b>4224</b>	900,909,096	35B2C828	750,757,576	2CBFA6C8h	450,454,552	1AD96418

**Table 2 Formatted Capacity Block Count (4TB, 2TB & 1TB models)**

Capacity (Blocks)						
Block Size	1600GB		960GB		800GB	
	Decimal	Hex	Decimal	Hex	Decimal	Hex
<b>512</b>	3,125,627,568	BA4D4AB0h	1,875,385,008	6FC81AB0	1,562,824,368	5D26CEB0h
<b>520</b>	3,059,487,192	B65C11D8h	1,835,692,320	6D6A7120	1,529,743,600	5B2E08F0h

**Table 2 Formatted Capacity Block Count (4TB, 2TB & 1TB models)**

Capacity (Blocks)						
Block Size	1600GB		960GB		800GB	
	Decimal	Hex	Decimal	Hex	Decimal	Hex
<b>524</b>	3,018,708,272	B3EDD530h	1,811,224,960	6BF51980	1,509,354,136	59F6EA98h
<b>528</b>	3,719,165,192	B157F738h	1,785,199,296	6A67FAC0	1,487,666,080	58ABFBA0h
<b>4096</b>	390,703,446	1749A956h	234,423,126	DF90356	195,353,046	BA4D9D6h
<b>4160</b>	383,076,928	16D54A40h	229,846,160	DB32C90	191,538,464	B6AA520h
<b>4192</b>	378,244,280	168B8CB8h	226,946,568	D86EE08	189,122,144	B45C660h
<b>4224</b>	375,378,792	165FD368h	225,227,280	D6CB210	187,689,400	B2FE9B8h

**Table 3 Formatted Capacity Block Count (4TB, 2TB & 1TB models)**

Capacity (Blocks)						
Block Size	480GB		400GB		200GB	
	Decimal	Hex	Decimal	Hex	Decimal	Hex
<b>512</b>	937,703,088	37E436B0	781,422,768	2E9390B0h	390,721,968	1749F1B0h
<b>520</b>	917,846,160	36B53890	764,871,800	2D970478h	382,435,904	16CB8240h
<b>524</b>	905,612,480	35FA8CC0	754,677,072	2CFB7550h	377,338,536	167DBAA8h
<b>528</b>	892,599,648	3533FD60	743,833,040	2C55FDD0h	371,916,520	162AFEE8h
<b>4096</b>	117,212,886	6FC86D6	97,677,846	5D27216h	48,840,246	2E93E36h
<b>4160</b>	114,923,080	6D99648	95,769,232	5B55290h	47,884,616	2DAA948h
<b>4192</b>	113,473,288	6C37708	94,561,072	5A2E330h	47,280,536	2D17198h
<b>4224</b>	112,613,640	6B65908	93,844,704	597F4E0h	46,922,352	2CBFA70h

### 3.6 Programmable drive capacity

Using the MODE SELECT command, the drive can change its capacity to something less than maximum. See the MODE SELECT (6) parameter list table in the *SAS Interface Manual*, part number 100293071. A value of zero in the Number of Blocks field indicates that the drive will not change the capacity it is currently formatted to have. A number other than zero and less than the maximum number of LBAs in the Number of Blocks field changes the total drive capacity to the value in the Number of Blocks field. A value greater than the maximum number of LBAs is rounded down to the maximum capacity.

### 3.7 Factory-installed options

OEMs may order the following items which are incorporated at the manufacturing facility during production or packaged before shipping. Some of the options available are (not an exhaustive list of possible options):

- Other capacities can be ordered depending on LBA size requested and other factors.
- Single-unit shipping pack. The drive is normally shipped in bulk packaging to provide maximum protection against transit damage. Units shipped individually require additional protection as provided by the single unit shipping pack. Users planning single unit distribution should specify this option.
- The *Safety and Regulatory Agency Specifications*, part number 75789512, is usually included with each standard OEM drive shipped, but extra copies may be ordered.

### 3.8 Thin Provisioning

#### 3.8.1 Logical Block Provisioning

The drive is designed with a feature called Thin Provisioning. Thin Provisioning is a technique which does not require Logical Blocks to be associated to Physical Blocks on the storage medium until such a time as needed. The use of Thin Provisioning is a major factor in SSD products because it reduces the amount of wear leveling and garbage collection that must be performed. The result is an increase in the products endurance. For more details on Logical Block Provisioning and Thin Provisioning, Reference the SBC-3 document provided by the T-10 committee.

#### 3.8.2 Thin Provisioning capabilities

The level of Thin Provisioning support may vary by product model. Devices that support Thin Provisioning are allowed to return a default data pattern for read requests made to Logical Blocks that have not been mapped to Physical Blocks by a previous WRITE command.

In order to determine if Thin Provisioning is supported and what features of it are implemented requires the system to send a READ CAPACITY 16 (9Eh) command to the drive. Thin Provisioning and the READ CAPACITY 16 (9Eh) command is defined in the Seagate SCSI Command Reference 100293068.

Product Configuration	LBPME	LBPRZ
Non-SED	Supported	Supported
SED	Supported	Supported

A logical block provisioning management enabled (LBPME) bit set to one indicates that the logical unit implements logical block provisioning management. An LBPME bit set to zero indicates that the logical unit is fully provisioned and does not implement logical block provisioning management.

A logical block provisioning read zeros (LBPRZ) bit set to one indicates that, for an unmapped LBA specified by a read operation, the device server sends user data with all bits set to zero to the data-in buffer. An LBPRZ bit set to zero indicates that, for an unmapped LBA specified by a read operation, the device server may send user data with all bits set to any value to the data-in buffer.

#### 3.8.3 UNMAP

The UNMAP command requests that the device server break the association of a specific Logical Block address from a Physical Block, thereby freeing up the Physical Block from use and no longer requiring it to contain user data. An unmapped block will respond to a READ command with data that is determined by the setting of the LBPRZ bit in the READ CAPACITY parameter data.

#### 3.8.4 FORMAT UNIT command

A device which supports Thin Provisioning will be capable of performing a SCSI FORMAT UNIT command which allocates Logical Blocks Addresses that are not linked to Physical Block Locations. A FORMAT command will cause all LBAs to become unmapped.

### 3.8.5 Protection Information (PI) and Security (SED)

The requirements in this section apply to any device which supports LBA unmapping.

In SCSI devices, unmapped LBAs are defined as part of the Thin Provisioning model. Support of the Thin Provisioning model is indicated by the LBPME bit having a value of '1' in the READ CAPACITY (16) parameter data.

When a region of LBA's are erased via cryptographic erase, as part of the erase, the LBAs are not unmapped.

If the host attempts to access an unmapped or trimmed LBA, the drive returns 0 data for unmapped LBAs. The drive shall report a value of '0' in the LBPRZ field returned in the READ CAPACITY (16) parameter data.

If the host attempts to access an unmapped LBA on a drive that has been formatted with Protection Information (PI), the drive shall return scrambled PI data for that LBA. Depending on the value of the RDPROTECT field in the data-access command CDB, this may result in the drive returning a standard PI error to the host.

If the host reduces the addressable capacity of the drive via a MODE SELECT command, the drive shall unmap or trim any LBA within the inaccessible region of the device.

Additionally, an UNMAP command is not permitted on a locked band.

	Drive Configuration		
	SD&D, SED and FIPS		
PI Setting	Disabled	Enabled	
PROT_EN bit	0	1	
LBPME bit	1	1	
LBPRZ bit	1	1	
PI Check Requested	N/A	Yes	No
DATA Returned for Thin Provisioned LBA	0x00	0x00	0x00
PI Returned for Thin Provisioned LBA	None	None	Scrambled PI data
PI Check Performed	N/A	Yes	No
Error reported to Host	No	Yes	No



## 4.0 Performance characteristics

This section provides detailed information concerning performance-related characteristics and features of: Seagate 1200.2 SAS SSD drives.

### 4.1 Internal drive characteristics

Flash Memory Type	NAND eMLC
Emulated LBA Size	512, 520, 524, 528, 4096, 4160, 4192 or 4224
Native Programmable	
Page Size	8192 User Bytes
Map Unit Size	4096
Default Transfer	
Alignment Offset	0

### 4.2 Performance characteristics

#### 4.2.1 Response time

Response time measurements are taken with nominal power at 25°C ambient temperature. The typical values in the table below are defined as follows:

- Page-to-page response time is an average of all possible page-to-page accesses for a sequentially preconditioned drive.
- Average response time is a true statistical random average of at least 5000 measurements of accesses between programmable pages on a randomly preconditioned drive.

**Table 4** *Typical Response Time (μsec)*

		All capacities <sup>1,2</sup>	
		Read	Write
Average	Typical <sup>3</sup>	105	25
Page to Page		105	25
Average Latency		105	25

1. Execution time measured from receipt of the Command to the Response.
2. Assumes no errors.
3. Typical response times are measured under nominal conditions of temperature and voltage as measured on a representative sample of drives.

These drives are designed to provide the highest possible performance under typical conditions. However, due to the nature of Flash memory technologies there are many factors that can result in values different than those stated in this specification.

#### 4.2.2 FORMAT UNIT command execution time for 512-byte LBA's (minutes)

The device may be formatted as either a Thin Provisioned device or a Fully Provisioned device. The default format is Thin Provisioned and is recommended for most applications. Thin Provisioning provides the most flexibility for the device to manage the flash medium to maximize endurance.

**Table 5** Maximum FORMAT UNIT Times (minutes)

Configuration	Format Mode	DCRT Bit	IP Bit	3840GB	3200GB	1920GB	1600GB
Non-SED	(Default) Thin Provisioned	DCRT = 0	IP = 0	5	5	5	5
Non-SED	(Default) Thin Provisioned	DCRT = 1	IP = 0	5	5	5	5
Non-SED	Fully Provisioned	DCRT = 0	IP = 1	10	10	10	10
Non-SED	Fully Provisioned	DCRT = 1	IP = 1	10	10	10	10
SED	(Default) Thin Provisioned	DCRT = 0	IP = 0	5	5	5	5
SED	(Default) Thin Provisioned	DCRT = 1	IP = 0	5	5	5	5
SED	Fully Provisioned	DCRT = 0	IP = 1	430	430	430	430
SED	Fully Provisioned	DCRT = 1	IP = 1	280	280	280	280

**Table 6** Maximum FORMAT UNIT Times (minutes)

Configuration	Format Mode	DCRT Bit	IP Bit	960GB	8000GB	480GB	400GB	200GB
Non-SED	(Default) Thin Provisioned	DCRT = 0	IP = 0	5	5	5	5	5
Non-SED	(Default) Thin Provisioned	DCRT = 1	IP = 0	5	5	5	5	5
Non-SED	Fully Provisioned	DCRT = 0	IP = 1	10	10	10	10	10
Non-SED	Fully Provisioned	DCRT = 1	IP = 1	10	10	10	10	10
SED	(Default) Thin Provisioned	DCRT = 0	IP = 0	5	5	5	5	5
SED	(Default) Thin Provisioned	DCRT = 1	IP = 0	5	5	5	5	5
SED	Fully Provisioned	DCRT = 0	IP = 1	430	430	430	430	430
SED	Fully Provisioned	DCRT = 1	IP = 1	280	280	280	280	280

## 4.2.3 Performance

Standard 2.5" Models - High Endurance	Notes	ST400FM0323	ST400FM0333	ST200FM0133	ST200FM0143
Maximum Burst Transfer Rate		1900 MB/s			
Sustained sequential 128KB read/write data transfer rate (MB/s max)	[1]	1700/850		1550/600	
Sustained 4KB random read/write command rate (IOPs)	[2]	200,000/120,000		200,000/120,000	
Sustainable 4KB Random combined IOPS (70%/30% Read/Write Mix)	[3]	130,000		100,000	
Standard 2.5" Models - Scalable Endurance	Notes	ST3840FM0043	ST3840FM0053	ST1920FM0043	ST1920FM0053
Maximum Burst Transfer Rate		1900 MB/s			
Sustained sequential 128KB read/write data transfer rate (MB/s max)	[1]	1700/770		1700/850	
Sustained 4KB random read/write command rate (IOPs)	[2]	190,000/15,000		190,000/12,000	
Sustainable 4KB Random combined IOPS (70%/30% Read/Write Mix)	[3]	42,000		36,000	
Standard 2.5" Models - Mainstream Endurance	Notes	ST3200FM0023 ST3200FM0033 ST3200FM0043	ST1600FM0003 ST1600FM0013 ST1600FM0023	ST800FM0173 ST800FM0183 ST800FM0213	ST400FM0233 ST400FM0243 ST400FM0293
Maximum Burst Transfer Rate		1900 MB/s			
Sustained sequential 128KB read/write data transfer rate (MB/s max)	[1]	1900/800	1900/850	1850/850	1550/625
Sustained 4KB random read/write command rate (IOPs)	[2]	200,000/80,000			180,000/67,000
Sustainable 4KB Random combined IOPS (70%/30% Read/Write Mix)	[3]	128,000	118,000	115,000	92,000
Standard 2.5" Models - Light Endurance	Notes	ST3840FM0003 ST3840FM0023	ST3200FM0063, ST3200FM0073 ST1600FM0073, ST1600FM0083		ST1920FM0003 ST1920FM0023
Maximum Burst Transfer Rate		1900 MB/s			
Sustained sequential 128KB read/write data transfer rate (MB/s max)	[1]	1850/770	1600/850		1850/850
Sustained 4KB random read/write command rate (IOPs)	[2]	180,000/30,000	180,000/ 20,000		180,000/ 30,000
Sustainable 4KB Random combined IOPS (65%/35% R/W, 70% Duty Cycle)	[3]	75,000	60,000	50,000	75,000

Standard 2.5" Models - Light Endurance	Notes	ST960FM0003 ST960FM0013	ST800FM0233 ST800FM0243	ST480FM0003 ST480FM0013	ST400FM0303 ST400FM0343
Maximum Burst Transfer Rate		1900 MB/s			
Sustained sequential 128KB read/write data transfer rate (MB/s max)	[1]	1700/850	1400/710	1550/615	1400/490
Sustained 4KB random read/write command rate (IOPs)	[2]	180,00/30,000	180,000/ 20,000	180,000/30,000	190,000/ 20,000
Sustainable 4KB Random combined IOPS for 5 year Endurance (65%/35% R/W, 70% Duty Cycle)	[3]	65,000	55,000	65,000	65,000

[1] Testing performed at Queue Depth = 32, Sequentially Preconditioned drive, using IOMeter 2006.7.27.

[2] Testing performed at Queue Depth = 32, Randomly Preconditioned drive, using IOMeter 2006.7.27.

[3] Testing performed at Queue Depth = 32, Non-Preconditioned drive, using IOMeter 2006.7.27.

**Note.** IOMeter is available at <http://www.iometer.org/> or <http://sourceforge.net/projects/iometer/>. IOMeter is licensed under the Intel Open Source License and the GNU General Public License. Intel does not endorse any IOMeter results.

Peak performance is defined as the typical best case performance that the product will be able to achieve when the product is preconditioned as mentioned and host commands are aligned on 4KB boundaries.

Sustained performance as defined as average values seen after 75% of write endurance has been consumed while operating in the specific workload with all host commands aligned on 4KB boundaries.

Due to the nature of Flash memory technologies there are many factors that can result in values different than those stated in this specification. Some discrepancies can be caused by bandwidth limitations in the host adapter, operating system, or driver limitations. It is not the intent of this manual to cover all possible causes of performance discrepancies.

When evaluating performance of SSD devices, it is recommended to measure performance of the device in a method that resembles the targeted application using real world data and workloads. Test time should also be adequately large to ensure that sustainable metrics and measures are obtained.

### 4.3 Start/stop time

The drive accepts the commands listed in the *SAS Interface Manual* less than 4 seconds after DC power has been applied.

If the drive receives a NOTIFY (ENABLE SPINUP) primitive through either port and has not received a START STOP UNIT command with the START bit equal to 0, the drive becomes ready for normal operations within 10 seconds (excluding the error recovery procedure).

If the drive receives a START STOP UNIT command with the START bit equal to 0 before receiving a NOTIFY (ENABLE SPINUP) primitive, the drive waits for a START STOP UNIT command with the START bit equal to 1. After receiving a START STOP UNIT command with the START bit equal to 1, the drive waits for a NOTIFY (ENABLE SPINUP) primitive. After receiving a NOTIFY (ENABLE SPINUP) primitive through either port, the drive becomes ready for normal operations within 5 seconds assuming the drive has been powered on for 4 minutes prior to last power off event (excluding the error recovery procedure).

If the drive receives a START STOP UNIT command with the START bit and IMMED bit equal to 1 and does not receive a NOTIFY (ENABLE SPINUP) primitive within 5 seconds, the drive fails the START STOP UNIT command.

The START STOP UNIT command may be used to command the drive to stop. Stop time is 3 seconds (maximum) from removal of DC power. SCSI stop time is 3 seconds. There is no power control switch on the drive.

## 4.4 Cache control

All default cache mode parameter values (Mode Page 08h) for standard OEM versions of this drive family are given in Section 11.3.2.

### 4.4.1 Caching write data

Write caching is a write operation by the drive that makes use of a drive buffer storage area where the data to be written to the medium is stored while the drive performs the WRITE command.

If the number of write data logical blocks exceed the size of the segment being written into, when the end of the segment is reached, the data is written into the beginning of the same cache segment, overwriting the data that was written there at the beginning of the operation; however, the drive does not overwrite data that has not yet been written to the medium.

If write caching is enabled (WCE=1), then the drive may return Good status on a WRITE command after the data has been transferred into the cache, but before the data has been written to the medium. If an error occurs while writing the data to the medium, and Good status has already been returned, a deferred error will be generated.

Data that has not been written to the medium is protected by a back up power source which provides the ability of the data to be written to non-volatile medium in the event of an unexpected power loss.

The SYNCHRONIZE CACHE command may be used to force the drive to write all cached write data to the medium. Upon completion of a SYNCHRONIZE CACHE command, all data received from previous WRITE commands will have been written to the medium. Section 11.3.2 shows the mode default settings for the drive.

### 4.4.2 Prefetch operation

If the Prefetch feature is enabled, data in contiguous logical blocks on the medium immediately beyond that which was requested by a Read command are retrieved and stored in the buffer for immediate transfer from the buffer to the host on subsequent Read commands that request those logical blocks (this is true even if cache operation is disabled). Though the prefetch operation uses the buffer as a cache, finding the requested data in the buffer is a prefetch hit, not a cache operation hit.

To enable Prefetch, use Mode Select page 08h, byte 12, bit 5 (Disable Read Ahead - DRA bit). DRA bit = 0 enables prefetch.

The drive does not use the Max Prefetch field (bytes 8 and 9) or the Prefetch Ceiling field (bytes 10 and 11).

When prefetch (read look-ahead) is enabled (enabled by DRA = 0), the drive enables prefetch of contiguous blocks from the medium when it senses that a prefetch hit will likely occur. The drive disables prefetch when it decides that a prefetch hit is not likely to occur.

## 5.0 Reliability specifications

The following reliability specifications assume correct host and drive operational interface, including all interface timings, power supply voltages, environmental requirements and drive mounting constraints.

### Read Error Rates <sup>1</sup>

Unrecovered Data

Less than 1 LBA in  $10^{17}$  bits transferred

Miscorrected Data

Less than 1 LBA in  $10^{21}$  bits transferred

Interface error rate:

Less than 1 error in  $10^{12}$  bits transferred

Mean Time Between Failure (MTBF):

2,500,000 hours

Annualized Failure Rate (AFR):

0.35%

Preventive maintenance:

None required

Typical Data Retention with Power removed

3 months

(at 40C up to 90% of write endurance) <sup>2</sup>

Endurance Rating: <sup>4</sup>

Method 2: TBW (per JEDEC JESD218)<sup>3</sup>

User Capacity in GB	Total PB Written	SD & D	SED	FIPS
200	9	ST200FM0133	ST200FM0143	
400	18	ST400FM0323	ST400FM0333	
400	7	ST400FM0233	ST400FM0243	ST400FM0293
800	14	ST800FM0173	ST800FM0183	ST800FM0213
1600	29	ST1600FM0003	ST1600FM0013	ST1600FM0023
3200	58	ST3200FM0023	ST3200FM0033	ST3200FM0043
400	2.1	ST400FM0303	ST400FM0343	
800	2.9	ST800FM0233	ST800FM0243	
1600	5.8	ST1600FM0073	ST1600FM0083	
3200	12	ST3200FM0063	ST3200FM0073	
480	2.6	ST480FM0003	ST480FM0013	
960	5.2	ST960FM0003	ST960FM0013	
1920	10	ST1920FM0003	ST1920FM0023	
3840	21	ST3840FM0003	ST3840FM0023	
1920	2.8	ST1920FM0043		

1. Error rate specified with automatic retries and data correction with ECC enabled and all flaws reallocated.
2. As NAND Flash devices age with use, the capability of the media to retain a programmed value begins to deteriorate. This deterioration is affected by the number of times a particular memory cell is programmed and subsequently erased. When a device is new, it has a powered off data retention capability of up to several years. With use the retention capability of the device is reduced. Temperature also has an effect on how long a Flash component can retain its programmed value with power removed. At high temperature the retention capabilities of the device are reduced. Data retention is not an issue with power applied to the SSD. The SSD drive contains firmware and hardware features that can monitor and refresh memory cells when power is applied.
3. Endurance rating is the expected amount of host data that can be written by product when subjected to a specified workload at a specified operating and storage temperature over the specified product life. For the specific workload to achieve this level of endurance, please reference JEDEC Specification JESD218. TBW is defined as  $1 \times 10^{12}$  Bytes.
4. Limited Warranty with Media Usage provides coverage for the warranty period or until the SSD Percentage Used Endurance Indicator, as defined in Section 5.2.6, reaches 100 whichever comes first.

## 5.1 Error rates

The error rates stated in this manual assume the following:

- The drive is operated in accordance with this manual using DC power as defined in paragraph 6.2.1, "Direct Current Consumption by Voltage Rail."
- Errors caused by host system failures are excluded from error rate computations.
- Assume random data.
- Default OEM error recovery settings are applied. This includes AWRE, ARRE, full read retries, full write retries and full retry time.

### 5.1.1 Unrecoverable Errors

An unrecoverable data error is defined as a failure of the drive to recover data from the media. These errors occur due to read or write problems. Unrecoverable data errors are only detected during read operations, but not caused by the read. If an unrecoverable data error is detected, a MEDIUM ERROR (03h) in the Sense Key will be reported. Multiple unrecoverable data errors resulting from the same cause are treated as 1 error.

### 5.1.2 Interface errors

An interface error is defined as a failure of the receiver on a port to recover the data as transmitted by the device port connected to the receiver. The error may be detected as a running disparity error, illegal code, loss of word sync, or CRC error.

## 5.2 Endurance Management

Customer satisfaction with Solid State Drives can be directly related to the internal algorithms which an SSD uses to manage the limited number of Program-Erase (PE) cycles that NAND Flash can withstand. These algorithms consist of Wearleveling, Garbage Collection, Write Amplification, Unmap, Data Retention, Lifetime Endurance Management.

### 5.2.1 Wear Leveling

Wear Leveling is a technique used by the drive to ensure that all Flash cells are written to or exercised as evenly as possible to avoid any hot spots where some cells are used up faster than other locations. Wear Leveling is automatically managed by the drive and requires no user interaction. The Seagate algorithm is tuned to operate only when needed to ensure reliable product operation.

### 5.2.2 Garbage Collection

Garbage Collection is a technique used by the drive to consolidate valid user data into a common cell range freeing up unused or obsolete locations to be erased and used for future storage needs. Garbage Collection is automatically managed by the drive and requires no user interaction. The Seagate algorithm is tuned to operate only when needed to ensure reliable product operation.

### 5.2.3 Write Amplification

While Write Amplification is not an algorithm, it is a major characteristic of SSD's that must be accounted for by all the algorithms that the SSD implements. The Write Amplification Factor of an SSD is defined as the ratio of Host/User data requested to be written to the actual amount of data written by the SSD internal to account for the user data and the housekeeping activities such as Wear Leveling and Garbage Collection. The Write Amplification Factor of an SSD can also be directly affected by the characteristics of the host data being sent to the SSD to write. The best Write Amplification Factor is achieved for data that is written in sequential LBA's that are aligned on 4KB boundaries. The worst case Write Amplification Factor typically occurs for randomly written LBA's of transfer sizes that are less than 4KB and that originate on LBA's that are not on 4KB boundaries.

### 5.2.4 UNMAP

A new SCSI command has been added to the SSD as part of the Thin Provisioning feature set. Use of the UNMAP command reduces the Write Amplification Factor of the drive during housekeeping tasks such as Wear Leveling and Garbage Collection. This is accomplished because the drive does not need to retain data which has been classified by the host as obsolete.



### 5.2.5 Data Retention

Data Retention is another major characteristic of SSD's that must be accounted for by all the algorithms that the SSD implements. While powered up, the Data Retention of SSD cells are monitored and rewritten if the cell levels decay to an unexpected level. Data Retention when the drive is powered off is affected by Program and Erase (PE) cycles and the temperature of the drive when stored.

### 5.2.6 SSD Percentage Used Endurance Indicator

An application can interrogate the drive through the host to determine an estimate of the percentage of device life that has been used. To accomplish this, issue a LOG SENSE command to log page 0x11. This allows applications to read the contents of the Percentage Used Endurance Indicator parameter code. The Percentage Used Endurance Indicator is defined in the T10 document SBC-3 available from the T10 committee.

## 5.3 Reliability and service

Integrators can enhance the reliability of Seagate 1200.2 SAS SSD drives by ensuring that the drive receives adequate cooling. Section 6.0 provides temperature measurements and other information that may be used to enhance the service life of the drive. Section 10.2 provides recommended air-flow information.

### 5.3.1 Annualized Failure Rate (AFR) and Mean Time Between Failure (MTBF)

The production drive shall achieve an AFR of 0.35% (MTBF of 2,500,000 hours) when operated in an environment that ensures the case temperatures do not exceed the values specified in Section 6.3. Operation at case temperatures outside the specifications in Section 6.3 may increase the product AFR (decrease the MTBF). The AFR (MTBF) is a population statistic not relevant to individual units.

The AFR (MTBF) specification is based on the following assumptions for Enterprise Storage System environments:

- 8760 power-on hours per year.
- 250 average on/off cycles per year.
- Operations at nominal voltages.
- Systems will provide adequate cooling to ensure the case temperatures specified in Section 6.3 are not exceeded. Temperatures outside the specifications in Section 6.3 will increase the product AFR and decrease the MTBF.

### 5.3.2 Preventive maintenance

No routine scheduled preventive maintenance is required.

### 5.3.3 Hot plugging the drive

When a drive is powered on by switching the power or hot plugged, the drive runs a self test before attempting to communicate on its' interfaces. When the self test completes successfully, the drive initiates a Link Reset starting with OOB. An attached device should respond to the link reset. If the link reset attempt fails, or any time the drive loses sync, the drive initiated link reset. The drive will initiate link reset once per second but alternates between port A and B. Therefore each port will attempt a link reset once per 2 seconds assuming both ports are out of sync.

If the self-test fails, the drive does not respond to link reset on the failing port.

**Note.** It is the responsibility of the systems integrator to assure that no temperature, energy, voltage hazard, or ESD potential hazard is presented during the hot connect/disconnect operation. Discharge the static electricity from the drive carrier prior to inserting it into the system.

### 5.3.4 S.M.A.R.T.

S.M.A.R.T. is an acronym for Self-Monitoring Analysis and Reporting Technology. This technology is intended to recognize conditions that indicate imminent drive failure and is designed to provide sufficient warning of a failure to allow administrators to back up the data before an actual failure occurs.

**Note.** The drive's firmware monitors specific attributes for degradation over time but can't predict instantaneous drive failures.

Each monitored attribute has been selected to monitor a specific set of failure conditions in the operating performance of the drive and the thresholds are optimized to minimize "false" and "failed" predictions.

#### Controlling S.M.A.R.T.

The operating mode of S.M.A.R.T. is controlled by the DEXCPT and PERF bits on the Informational Exceptions Control mode page (1Ch). Use the DEXCPT bit to enable or disable the S.M.A.R.T. feature. Setting the DEXCPT bit disables all S.M.A.R.T. functions. When enabled, S.M.A.R.T. collects on-line data as the drive performs normal read and write operations. When the PERF bit is set, the drive is considered to be in "On-line Mode Only" and will not perform off-line functions.

An application can measure off-line attributes and force the drive to save the data by using the REZERO UNIT command. Forcing S.M.A.R.T. resets the timer so that the next scheduled interrupt is in one hour.

An application can interrogate the drive through the host to determine the time remaining before the next scheduled measurement and data logging process occurs. To accomplish this, issue a LOG SENSE command to log page 0x3E. This allows applications to control when S.M.A.R.T. interruptions occur. Forcing S.M.A.R.T. with the REZERO UNIT command resets the timer.

#### Performance impact

S.M.A.R.T. attribute data is saved to the media so that the events that caused a predictive failure can be recreated. The drive measures and saves parameters once every hour subject to an idle period on the drive interfaces. The process of measuring off-line attribute data and saving data to the media is interruptible. The maximum on-line only processing delay is summarized below

**Table 7**

#### Maximum processing delay

	Fully-enabled delay DEXCPT = 0
S.M.A.R.T. delay times	75 ms

#### Reporting control

Reporting is controlled by the MRIE bits in the Informational Exceptions Control mode page (1Ch). Subject to the reporting method. For example, if the MRIE is set to one, the firmware will issue to the host an 01-5D00 sense code. The FRU field contains the type of predictive failure that occurred. The error code is preserved through bus resets and power cycles.

#### Determining rate

S.M.A.R.T. monitors the rate at which errors occur and signals a predictive failure if the rate of degraded errors increases to an unacceptable level. To determine rate, error events are logged and compared to the number of total operations for a given attribute. The interval defines the number of operations over which to measure the rate. The counter that keeps track of the current number of operations is referred to as the Interval Counter.

S.M.A.R.T. measures error rates. All errors for each monitored attribute are recorded. A counter keeps track of the number of errors for the current interval. This counter is referred to as the Failure Counter.

Error rate is the number of errors per operation. The algorithm that S.M.A.R.T. uses to record rates of error is to set thresholds for the number of errors and appropriate interval. If the number of errors exceeds the threshold before the interval expires, the error rate is considered to be unacceptable. If the number of errors does not exceed the threshold before the interval expires, the error rate is considered to be acceptable. In either case, the interval and failure counters are reset and the process starts over.

### Predictive failures

S.M.A.R.T. signals predictive failures when the drive is performing unacceptably for a period of time. The firmware keeps a running count of the number of times the error rate for each attribute is unacceptable. To accomplish this, a counter is incremented each time the error rate is unacceptable and decremented (not to exceed zero) whenever the error rate is acceptable. If the counter continually increments such that it reaches the predictive threshold, a predictive failure is signaled. This counter is referred to as the Failure History Counter. There is a separate Failure History Counter for each attribute.

#### 5.3.5 Thermal monitor

Seagate 1200.2 SAS SSD drives implement a temperature warning system which:

1. Signals the host if the temperature exceeds a value which would threaten the drive.
2. Signals the host if the temperature exceeds a user-specified value. (i.e., the reference temperature value)
3. Saves a S.M.A.R.T. data frame on the drive which exceeds the threatening temperature value.

A temperature sensor monitors the drive temperature and issues a warning over the interface when the temperature exceeds a set threshold. The temperature is measured at power-up and then at ten-minute intervals after power-up.

The thermal monitor system generates a warning code of 01-0B01 when the temperature exceeds the specified limit in compliance with the SCSI standard.

This feature is controlled by the Enable Warning (EWasc) bit, and the reporting mechanism is controlled by the Method of Reporting Informational Exceptions field (MRIE) on the Informational Exceptions Control (IEC) mode page (1Ch).

#### 5.3.6 Drive Self Test (DST)

Drive Self Test (DST) is a technology designed to recognize drive fault conditions that qualify the drive as a failed unit. DST validates the functionality of the drive at a system level.

There are two test coverage options implemented in DST:

1. Extended test
2. Short test

The most thorough option is the extended test that performs various tests on the drive and scans every logical block address (LBA) of the drive. The short test is time-restricted and limited in length—it does not scan the entire media contents, but does some fundamental tests and scans portions of the media.

If DST encounters an error during either of these tests, it reports a "diagnostic failed" condition. If the drive fails the test, remove it from service and return it to Seagate for service.

##### 5.3.6.1 DST failure definition

The drive will present a "diagnostic failed" condition through the self-tests results value of the diagnostic log page if a functional failure is encountered during DST. The drive parameters are not modified to test the drive more stringently, and the recovery capabilities are not reduced. All retries and recovery processes are enabled during the test. If data is recoverable, no failure condition will be reported regardless of the recovery processes required to recover the data.

The following conditions are considered DST failure conditions:

- Read error after recovery attempts are exhausted
- Write error after recovery attempts are exhausted

Recovered errors will not be reported as diagnostic failures.

### 5.3.6.2 Implementation

This section provides all of the information necessary to implement the DST function on this drive.

#### 5.3.6.2.1 State of the drive prior to testing

The drive must be in a ready state before issuing the SEND DIAGNOSTIC command. There are multiple reasons why a drive may not be ready, some of which are valid conditions, and not errors. For example, a drive may be in process of doing a FORMAT UNIT, or another DST. It is the responsibility of the host application to determine the "not ready" cause.

#### 5.3.6.2.2 Invoking DST

To invoke DST, submit the SEND DIAGNOSTIC command with the appropriate Function Code (001b for the short test or 010b for the extended test) in bytes 1, bits 5, 6, and 7.

#### 5.3.6.2.3 Short and extended tests

DST has two testing options:

1. short
2. extended

These testing options are described in the following two subsections.

Each test consists of two segments: an electrical test segment and a read/verify scan segment.

##### Short test (Function Code: 001b)

The purpose of the short test is to provide a time-limited test that tests as much of the drive as possible within 120 seconds. The short test does not scan the entire media contents, but does some fundamental tests and scans portions of the media. A complete read/verify scan is not performed and only factual failures will report a "diagnostic failed" condition. This option provides a quick confidence test of the drive.

##### Extended test (Function Code: 010b)

The objective of the extended test option is to empirically test critical drive components. The read operation tests the media contents. The integrity of the media is checked through a read/verify scan of the media.

The anticipated length of the Extended test is reported through the Control Mode page.

#### 5.3.6.2.4 Log page entries

When the drive begins DST, it creates a new entry in the Self-test Results Log page. The new entry is created by inserting a new self-test parameter block at the beginning of the self-test results log parameter section of the log page. Existing data will be moved to make room for the new parameter block. The drive reports 20 parameter blocks in the log page. If there are more than 20 parameter blocks, the least recent parameter block will be deleted. The new parameter block will be initialized as follows:

1. The Function Code field is set to the same value as sent in the DST command
2. The Self-Test Results Value field is set to Fh
3. The drive will store the log page to non-volatile memory

After a self-test is complete or has been aborted, the drive updates the Self-Test Results Value field in its Self-Test Results Log page in non-volatile memory. The host may use LOG SENSE to read the results from up to the last 20 self-tests performed by the drive. The self-test results value is a 4-bit field that reports the results of the test. If the field is set to zero, the drive passed with no errors detected by the DST. If the field is not set to zero, the test failed for the reason reported in the field.

The drive will report the failure condition and LBA (if applicable) in the Self-test Results Log parameter. The Sense key, ASC, ASCQ, and FRU are used to report the failure condition.

#### **5.3.6.2.5 Abort**

There are several ways to abort a diagnostic. Applications can use a SCSI Bus Reset or a Bus Device Reset message to abort the diagnostic.

Applications can abort a DST executing in background mode by using the abort code in the DST Function Code field. This will cause a 01 (self-test aborted by the application client) code to appear in the self-test results values log. All other abort mechanisms will be reported as a 02 (self-test routine was interrupted by a reset condition).

#### **5.3.7 Product warranty**

See "Seagate® Technology Support Services" on page 6 for warranty information.

Warranty terms will vary based on type of warranty chosen: "Managed Life Warranty" or "Limited Warranty with Media Usage". Consult the Seagate sales representative for warranty terms and conditions.

##### **Limited Warranty with Media Usage**

This warranty is based on the shorter of term and endurance usage of the drive.

#### **Shipping**

When transporting or shipping a drive, use only a Seagate-approved container. Keep the original box. Seagate approved containers are easily identified by the Seagate Approved Package label. Shipping a drive in a non-approved container voids the drive warranty.

Seagate repair centers may refuse receipt of components improperly packaged or obviously damaged in transit. Contact the authorized Seagate distributor to purchase additional boxes. Seagate recommends shipping by an air-ride carrier experienced in handling computer equipment.

#### **Product repair and return information**

Seagate customer service centers are the only facilities authorized to service Seagate drives. Seagate does not sanction any third-party repair facilities. Any unauthorized repair or tampering with the factory seal voids the warranty.

#### **Storage**

You can store the drive for a maximum of 180 days in the original unopened Seagate shipping package or 60 days, unpackaged, in the defined non-operating limits (refer to environmental section in this manual). You can extend storage to 1 year packaged or unpackaged under optimal environmental conditions (<40°C, <40% relative humidity non-condensing, and non-corrosive environment). During any storage period you must follow the drive non-operational temperature, humidity, wet bulb, atmospheric conditions, shock, vibration, magnetic and electrical field specifications.

## 6.0 Physical/electrical specifications

This section provides information relating to the physical and electrical characteristics of the drive.

### 6.1 Power specifications

The 2.5" drive receives DC power (+5V and +12V) through the standard SAS interface. The minimum current loading for each supply voltage is not less than 1.7% of the maximum operating current shown. Both +5V and +12V supplies should employ separate ground returns.

Where power is provided to multiple drives from a common supply, careful consideration for individual drive power requirements should be noted. Where multiple units are powered on simultaneously, the peak starting current must be available to each device.

#### 12V Requirements

Supply Tolerance	+10% / -7%
Absolute Maximum Voltage	15V
Supply Rise Time	0 to 500 ms
Supply Drop Time	0.12 to 500 ms
Typical Capacitance	21 $\mu$ f

#### 5V Requirements

Supply Tolerance	+10% / -7%
Absolute Maximum Voltage	5.5V
Supply Rise Time	0 to 500 ms
Supply Drop Time	0.05 to 500 ms
Typical Capacitance	74 $\mu$ f

#### 6.1.1 Conducted noise immunity

Noise is specified as a periodic and random distribution of frequencies covering a defined frequency. Maximum allowed noise values given below are peak-to-peak measurements and apply at the drive power connector.

- +5v = 250 mV pp from 100 Hz to 20 MHz.
- +12v = 450 mV pp from 100 Hz to 100 KHz.  
250 mV pp from 100 KHz to 20 MHz.  
150 mV pp from 20 MHz to 80 MHz.

#### 6.1.2 Power sequencing

The drive does not require power sequencing. The drive protects against inadvertent writing during power-up and down.

## 6.2 Power consumption

Power requirements for the drives are listed in the tables in Section 6.2.1. Typical power measurements are based on an average of drives tested, under nominal conditions, using the listed input voltage at 60°C internal temperature.

- Startup power

Startup power is measured from the time of power-on to the time that the drive reaches operating condition and can process media access commands.

- Peak operating mode

During peak operating mode, the drive is tested in various read and write access patterns to simulate the worst-case power consumption.

- Idle mode power

Idle mode power is measured with the drive powered up and ready for media access commands, with no media access commands having been received from the host.

### 6.2.1 Direct Current Consumption by Voltage Rail

**Table 8 Mainstream Endurance 2.5" model DC power requirements**

Parameter		3200GB (12.0Gb) Mainstream Endurance			
Regulation <sup>[4]</sup>			±5%	±5% <sup>[2]</sup>	
Voltage			+5V	+12V <sup>[2]</sup>	
			Current (A)	Current (A)	Power (W)
Average idle current <sup>[1]</sup>		DCx	0.59	0.20	5.40
Maximum starting current					
	(peak DC) DC		0.94	0.61	12.06
	(peak AC) AC		2.05	1.01	22.37
Delayed start (max) DC <sup>[1] [3]</sup>		3σ	0.54	0.24	5.50
Operating current (random read):					
	Typical DC <sup>[1]</sup>	DCx	0.72	0.23	6.32
	Maximum DC <sup>[1]</sup>	3σ	0.73	0.24	6.53
	Maximum (peak) DC	3σ	0.96	0.50	
Operating current (random write)					
	Typical DC	DCx	0.79	0.44	9.28
	Maximum DC	3σ	0.81	0.47	9.69
	Maximum (peak) DC	3σ	1.56	0.94	
Operating current (sequential read)					
	Typical DC	DCx	1.00	0.35	9.15
	Maximum DC	3σ	1.03	0.38	9.66
	Maximum (peak) DC	3σ	2.24	0.62	
Operating current (sequential write)					
	Typical DC	DCx	0.98	0.69	13.15
	Maximum DC	3σ	1.00	0.74	13.86
	Maximum (peak) DC	3σ	2.14	1.44	

**Table 9 Mainstream Endurance 2.5" model DC power requirements**

Parameter		1600GB (12.0Gb) Mainstream Endurance			
Regulation <sup>[4]</sup>			±5%	±5% <sup>[2]</sup>	
Voltage			+5V	+12V <sup>[2]</sup>	
			Current (A)	Current (A)	
			Power (W)		
Average idle current <sup>[1]</sup>		DC $\bar{x}$	0.55	0.12	4.14
Maximum starting current					
(peak DC) DC			0.93	0.50	10.62
(peak AC) AC			1.94	0.90	20.51
Delayed start (max) DC <sup>[1] [3]</sup>		3 $\sigma$	0.53	0.13	4.19
Operating current (random read):					
Typical DC <sup>[1]</sup>		DC $\bar{x}$	0.69	0.14	5.13
Maximum DC <sup>[1]</sup>		3 $\sigma$	0.71	0.15	5.37
Maximum (peak) DC		3 $\sigma$	0.98	0.24	7.78
Operating current (random write)					
Typical DC		DC $\bar{x}$	0.76	0.30	7.44
Maximum DC		3 $\sigma$	0.78	0.33	7.90
Maximum (peak) DC		3 $\sigma$	1.72	0.82	18.44
Operating current (sequential read)					
Typical DC		DC $\bar{x}$	0.96	0.21	7.33
Maximum DC		3 $\sigma$	0.98	0.22	7.56
Maximum (peak) DC		3 $\sigma$	2.22	0.74	19.98
Operating current (sequential write)					
Typical DC		DC $\bar{x}$	0.94	0.51	10.78
Maximum DC		3 $\sigma$	0.97	0.51	11.01
Maximum (peak) DC		3 $\sigma$	1.72	1.16	22.52



**Table 10 Mainstream Endurance 2.5" model DC power requirements**

Parameter		400GB (12.0Gb) Mainstream Endurance		
Regulation <sup>[4]</sup>			±5%	±5% <sup>[2]</sup>
Voltage			+5V	+12V <sup>[2]</sup>
			Current (A)	Current (A)
			Power (W)	
Average idle current <sup>[1]</sup>		DC $\bar{x}$	0.63	0.03
Maximum starting current				
(peak DC) DC			1.05	0.34
(peak AC) AC			1.35	0.39
Delayed start (max) DC <sup>[1] [3]</sup>		3 $\sigma$	0.49	0.02
Operating current (random read):				
Typical DC <sup>[1]</sup>		DC $\bar{x}$	0.71	0.06
Maximum DC <sup>[1]</sup>		3 $\sigma$	0.72	0.06
Maximum (peak) DC		3 $\sigma$	1.10	0.18
Operating current (random write)				
Typical DC		DC $\bar{x}$	0.68	0.20
Maximum DC		3 $\sigma$	0.70	0.21
Maximum (peak) DC		3 $\sigma$	1.22	0.50
Operating current (sequential read)				
Typical DC		DC $\bar{x}$	0.80	0.09
Maximum DC		3 $\sigma$	0.81	0.10
Maximum (peak) DC		3 $\sigma$	1.48	0.32
Operating current (sequential write)				
Typical DC		DC $\bar{x}$	0.76	0.25
Maximum DC		3 $\sigma$	0.78	0.25
Maximum (peak) DC		3 $\sigma$	1.32	0.54

**Table 11 Light Endurance 2.5" model DC power requirements**

Parameter		3840GB (12.0Gb) Light Endurance		
Regulation <sup>[4]</sup>			±5%	±5% <sup>[2]</sup>
Voltage			+5V	+12V <sup>[2]</sup>
			<b>Current (A)</b>	<b>Current (A)</b>
				<b>Power (W)</b>
Average idle current <sup>[1]</sup>		DC $\bar{x}$	0.66	0.22
Maximum starting current				
(peak DC) DC			0.98	0.59
(peak AC) AC			2.05	1.06
Delayed start (max) DC <sup>[1] [3]</sup>		3 $\sigma$	0.56	0.26
Operating current (random read):				
Typical DC <sup>[1]</sup>		DC $\bar{x}$	0.71	0.22
Maximum DC <sup>[1]</sup>		3 $\sigma$	0.72	0.24
Maximum (peak) DC		3 $\sigma$	0.96	0.52
Operating current (random write)				
Typical DC		DC $\bar{x}$	0.77	0.44
Maximum DC		3 $\sigma$	0.79	0.50
Maximum (peak) DC		3 $\sigma$	1.40	0.96
Operating current (sequential read)				
Typical DC		DC $\bar{x}$	1.02	0.35
Maximum DC		3 $\sigma$	1.04	0.38
Maximum (peak) DC		3 $\sigma$	2.12	0.62
Operating current (sequential write)				
Typical DC		DC $\bar{x}$	0.96	0.71
Maximum DC		3 $\sigma$	0.97	0.76
Maximum (peak) DC		3 $\sigma$	2.24	1.32

**Table 12 Mainstream Endurance 2.5" model DC power requirements**

Parameter		800GB (12.0Gb) Mainstream Endurance		
		+5 V	+12 V	Power
Voltage		+5 V	+12 V	Power
Regulation		+/-5%	+/-5%	(watts)
Average Idle Current		0.62	0.04	3.55
Peak Operating Current (random read)				
	Typical DC	0.71	0.08	4.57
	Maximum DC	0.72	0.09	4.66
	Maximum DC (peak)	1.20	0.24	
Peak Operating Current (random write)				
	Typical DC	0.71	0.20	5.91
	Maximum DC	0.72	0.21	6.12
	Maximum DC (peak)	1.28	0.48	
Peak operating current (sequential read)				
	Typical DC	0.82	0.11	5.39
	Maximum DC	0.86	0.11	5.63
	Maximum DC (peak)	1.58	0.36	
Peak operating current (sequential write)				
	Typical DC	0.83	0.26	7.26
	Maximum DC	0.84	0.27	7.39
	Maximum DC (peak)	1.74	1.08	

**Table 13 Mainstream Endurance 2.5" model DC power requirements**

Parameter	ST960FM0003(12.0GB) Mainstream Endurance		
	+5 V	+12 V	Power
Regulation	+/-5%	+/-5%	(watts)
Average Idle Current	0.62	0.07	3.91
Peak Operating Current (random read):			
Typical DC	0.71	0.10	4.80
Maximum DC	0.72	0.12	5.06
Maximum DC (peak)	1.16	0.24	
Peak Operating Current (random write):			
Typical DC	0.74	0.19	5.99
Maximum DC	0.79	0.21	6.50
Maximum DC (peak)	1.56	0.76	
Peak operating current (sequential read):			
Typical DC	0.79	0.11	5.33
Maximum DC	0.81	0.12	5.43
Maximum DC (peak)	1.52	0.34	
Peak operating current (sequential write):			
Typical DC	0.84	0.27	7.36
Maximum DC	0.85	0.27	7.50
Maximum DC (peak)	1.58	0.92	

**Table 14 Light Endurance 2.5" model DC power requirements**

Parameter		1920GB (12.0Gb) Light Endurance			
Regulation <sup>[4]</sup>			±5%	±5% <sup>[2]</sup>	
Voltage			+5V	+12V <sup>[2]</sup>	
			<b>Current (A)</b>	<b>Current (A)</b>	<b>Power (W)</b>
Average idle current <sup>[1]</sup>		DC $\bar{x}$	0.54	0.12	4.17
Maximum starting current					
(peak DC) DC			0.90	0.49	10.41
(peak AC) AC			1.83	0.90	20.00
Delayed start (max) DC <sup>[1] [3]</sup>		3 $\sigma$	0.52	0.13	4.16
Operating current (random read):					
Typical DC <sup>[1]</sup>		DC $\bar{x}$	0.68	0.14	5.08
Maximum DC <sup>[1]</sup>		3 $\sigma$	0.69	0.15	5.22
Maximum (peak) DC		3 $\sigma$	0.94	0.26	
Operating current (random write)					
Typical DC		DC $\bar{x}$	0.75	0.33	7.68
Maximum DC		3 $\sigma$	0.76	0.35	8.03
Maximum (peak) DC		3 $\sigma$	1.40	0.82	
Operating current (sequential read)					
Typical DC		DC $\bar{x}$	0.94	0.22	7.36
Maximum DC		3 $\sigma$	0.96	0.23	7.50
Maximum (peak) DC		3 $\sigma$	2.20	0.78	
Operating current (sequential write)					
Typical DC		DC $\bar{x}$	0.91	0.51	10.65
Maximum DC		3 $\sigma$	0.93	0.52	10.95
Maximum (peak) DC		3 $\sigma$	1.74	1.20	

[1] Measured with average reading DC ammeter. Instantaneous +12V current peaks will exceed these values. Power supply at nominal voltage. N (number of drives tested) = 6, 60 Degrees C internal.

[2] For +12 V, a -10% tolerance is allowed during initial start but must return to ±5% before reaching ready state. The ±5% must be maintained after the drive signifies that its power-up sequence has been completed and that the drive is able to accept selection by the host initiator.

[3] This condition occurs after OOB and Speed Negotiation completes but before the drive has received the Notify Spinup primitive.

[4] See paragraph 6.1.1, "Conducted noise immunity." Specified voltage tolerance includes ripple, noise, and transient response.

#### General DC power requirement notes.

1. Minimum current loading for each supply voltage is not less than 1.7% of the maximum operating current shown.
2. The +5V and +12V supplies should employ separate ground returns.
3. Where power is provided to multiple drives from a common supply, careful consideration for individual drive power requirements should be noted. Where multiple units are powered on simultaneously, the peak starting current must be available to each device.
4. Parameters, other than start, are measured after a 10-minute warm up.

### 6.2.2 Drive Performance Based on Power Setting

#### Performance vs Power Choice Limit: ME 3200

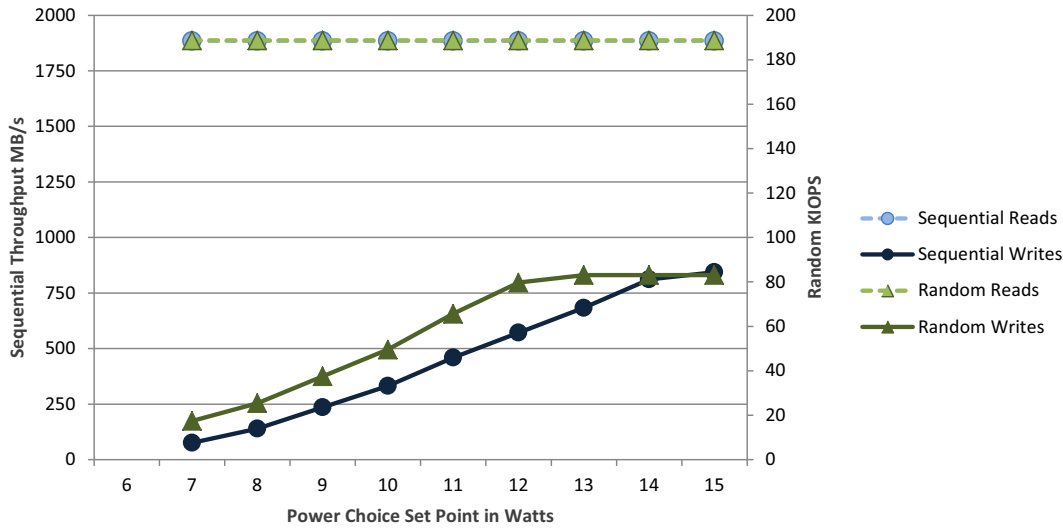


Figure 1. 3200GB Mainstream Endurance: Performance vs Power Limit Settings IOPs chart

#### Performance vs Power Choice Limit: ME 1600

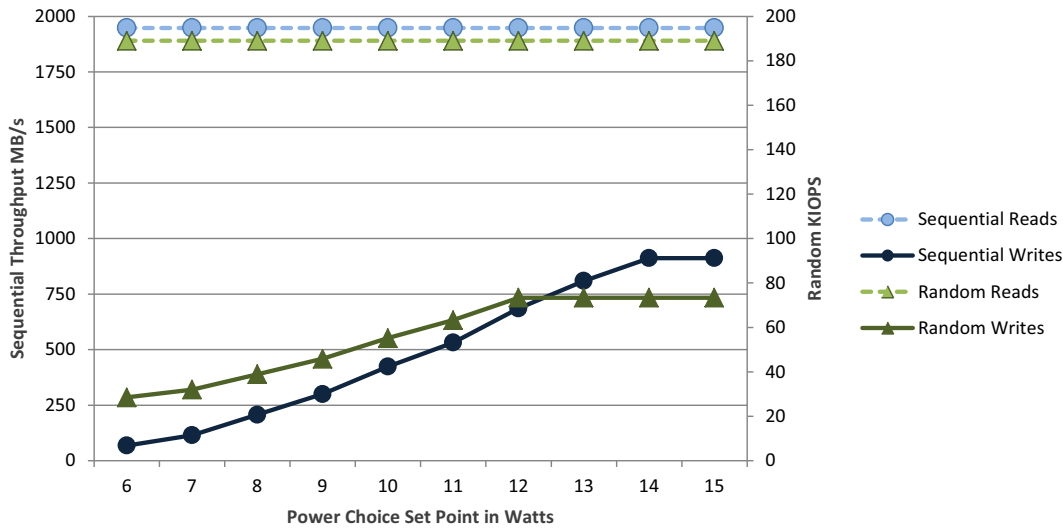


Figure 2. 1600GB Mainstream Endurance: Performance vs Power Limit Settings IOPs chart

### Performance vs Power Choice Limit: ME 800

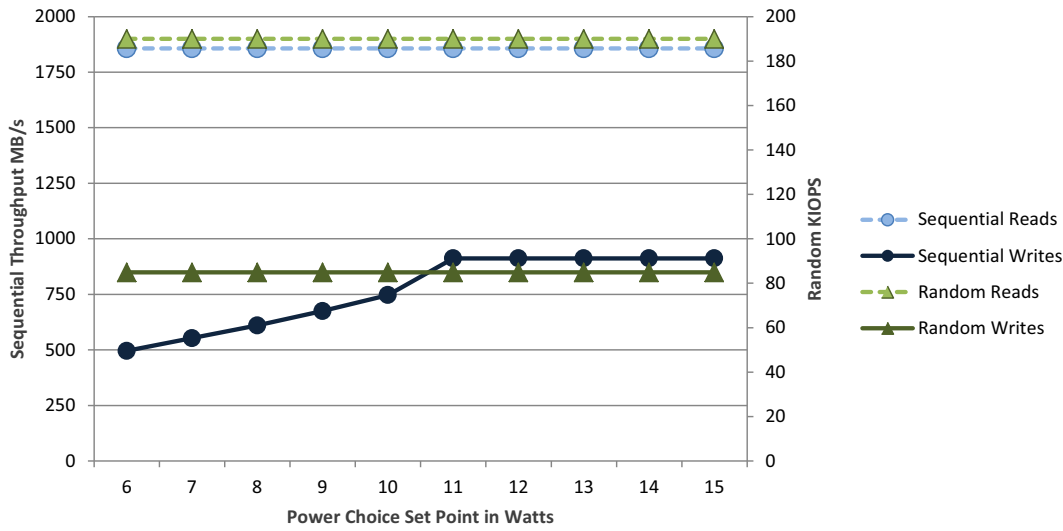


Figure 3. 800GB Mainstream Endurance: Performance vs Power Limit Settings IOPs chart

### Performance vs Power Choice Limit: ME 400

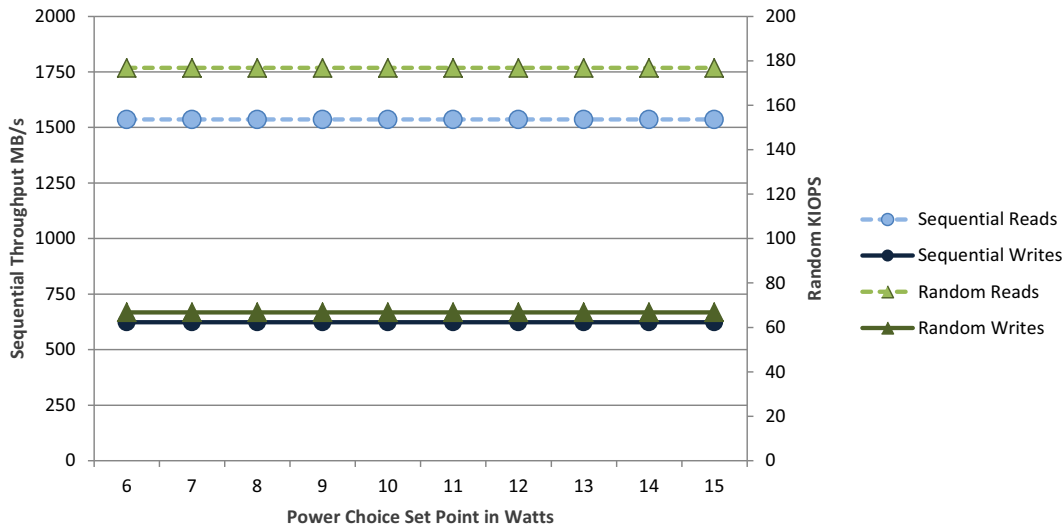


Figure 4. 400GB Mainstream Endurance: Performance vs Power Limit Settings IOPs chart

### Performance vs Power Choice Limit: LE 3200

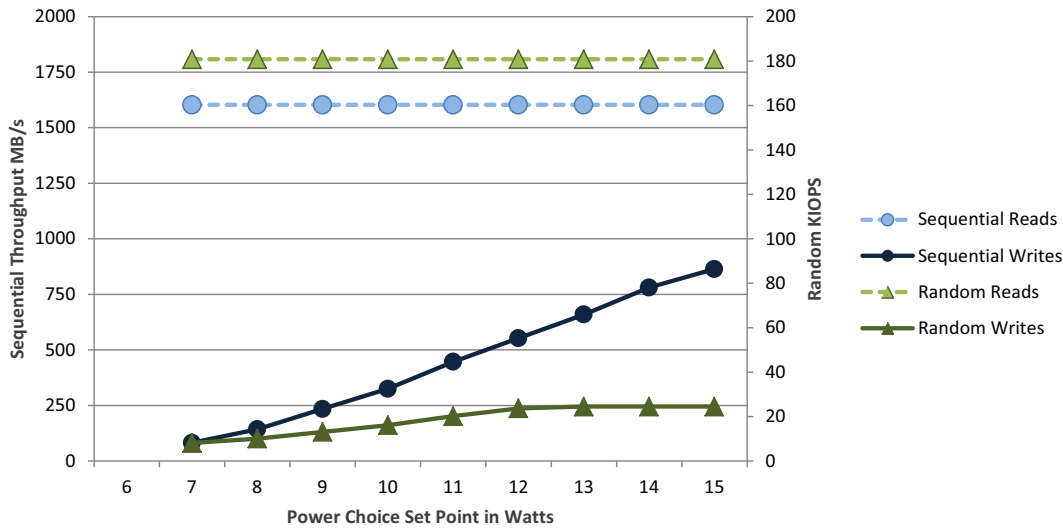


Figure 5. 3200GB Light Endurance: Performance vs Power Limit Settings IOPs chart

### Performance vs Power Choice Limit: LE 1600

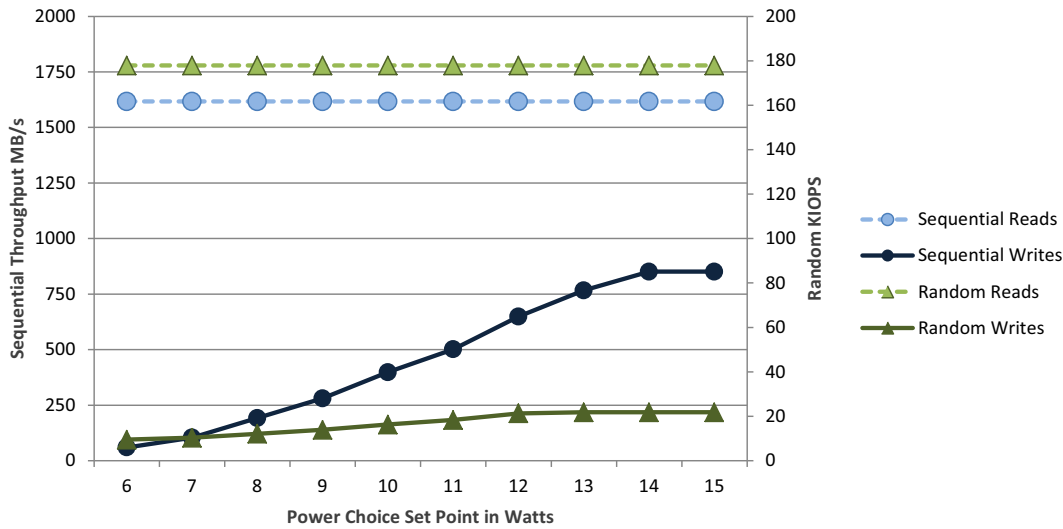


Figure 6. 1600GB Light Endurance: Performance vs Power Limit Settings IOPs chart



### Performance vs Power Choice Limit: LE 800

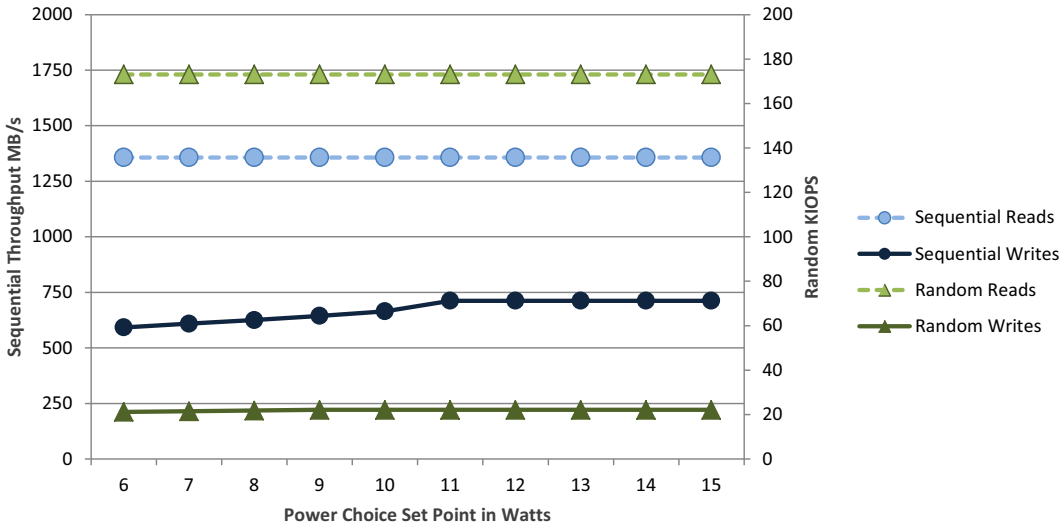


Figure 7. 800GB Light Endurance: Performance vs Power Limit Settings IOPS chart

### Performance vs Power Choice Limit: LE 400

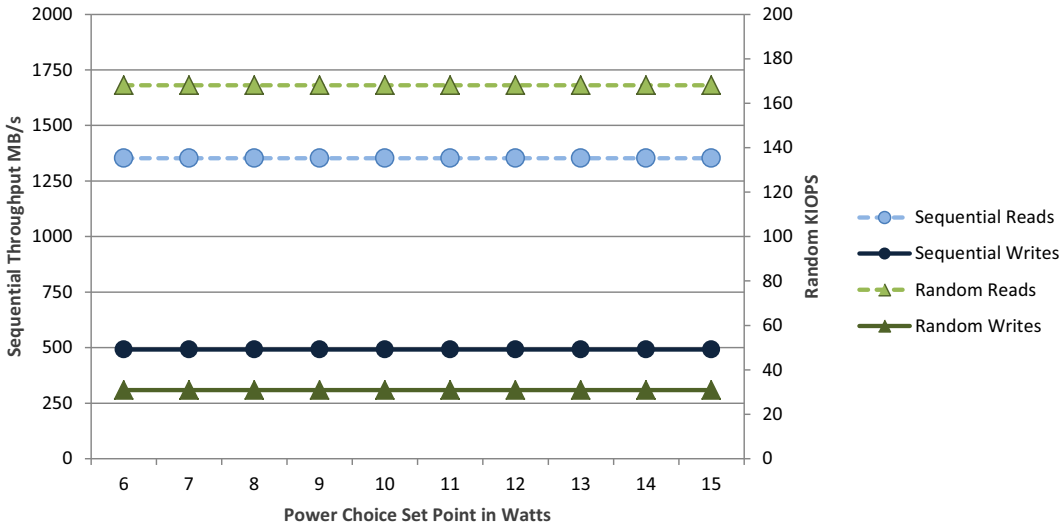


Figure 8. 400GB Light Endurance: Performance vs Power Limit Settings IOPS chart

### Performance vs Power Choice Limit: LE 3840

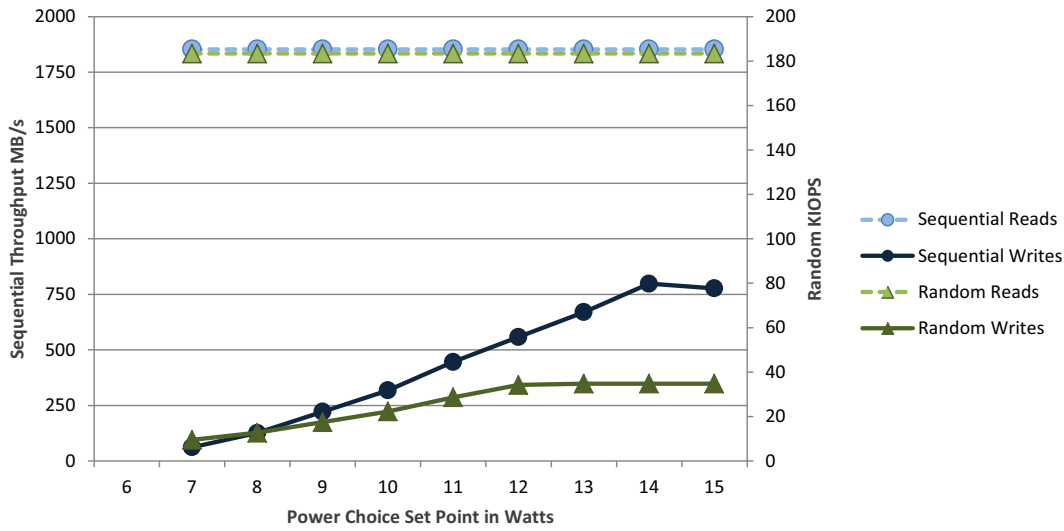


Figure 9. 3840GB Light Endurance: Performance vs Power Limit Settings IOPs chart

### Performance vs Power Choice Limit: LE 1920

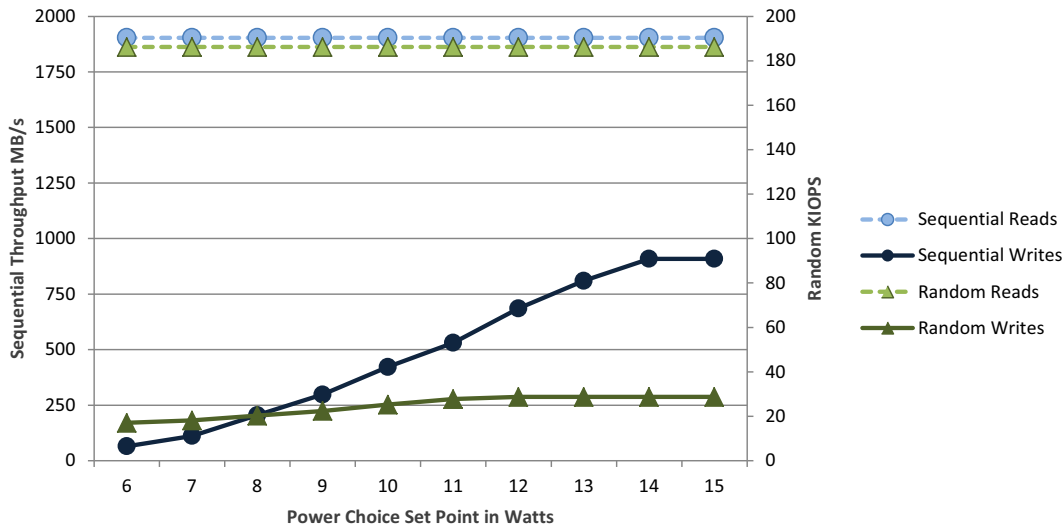


Figure 10. 1920GB Light Endurance: Performance vs Power Limit Settings IOPs chart

### Performance vs Power Choice Limit: LE 960

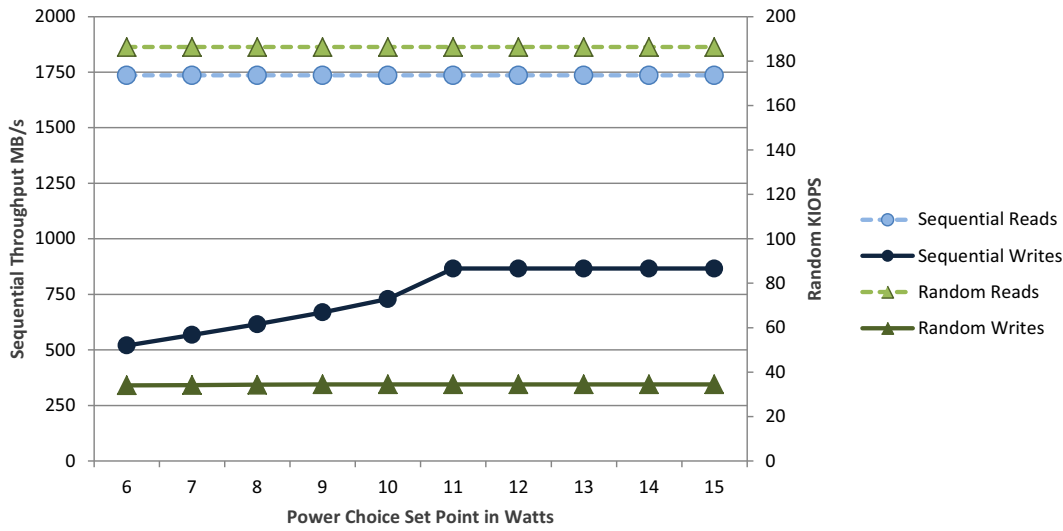


Figure 11. 960GB Light Endurance: Performance vs Power Limit Settings IOPS chart

### Performance vs Power Choice Limit: LE 480

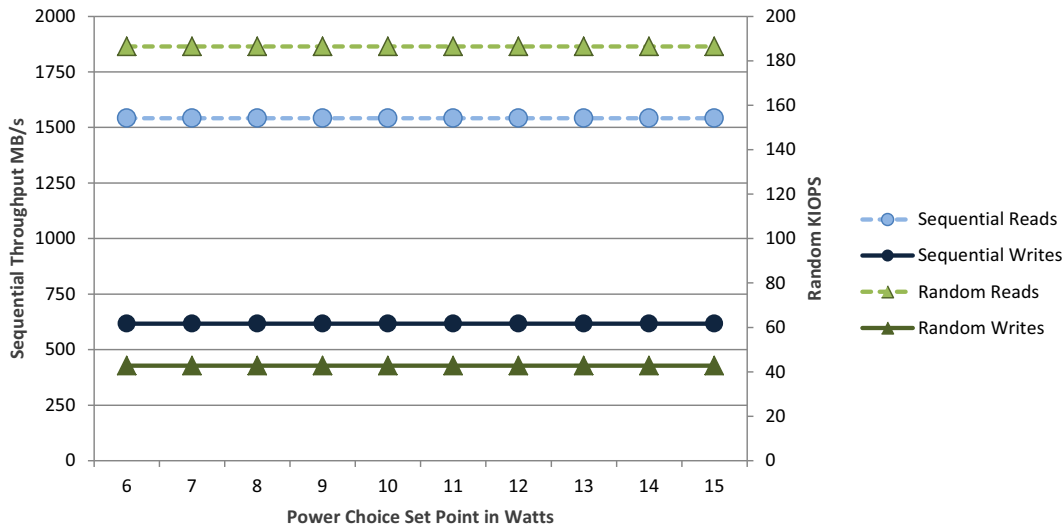


Figure 12. 480GB Light Endurance: Performance vs Power Limit Settings IOPS chart

### Performance vs Power Choice Limit: SE 3840

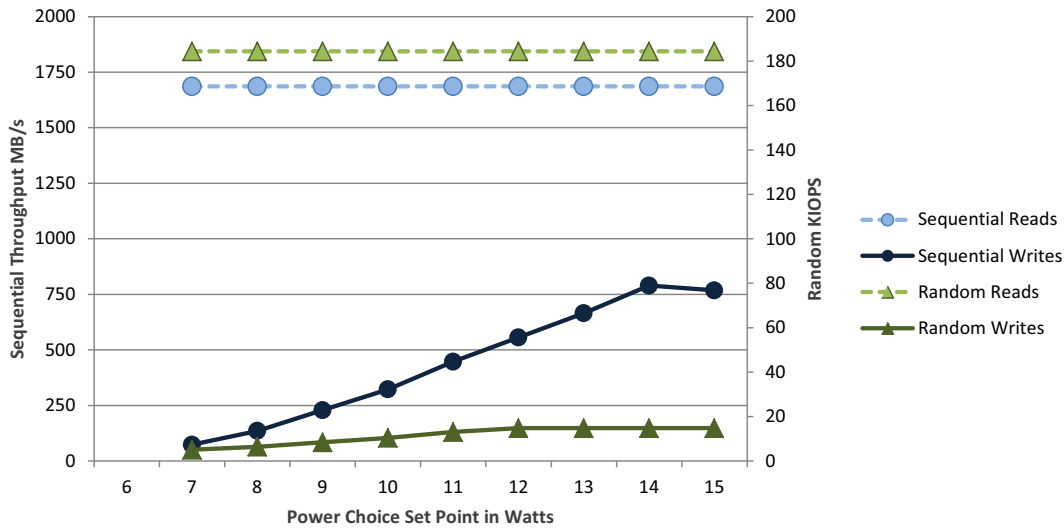


Figure 13. 3840GB Scalable Endurance: Performance vs Power Limit Settings IOPs chart

### Performance vs Power Choice Limit: SE 1920

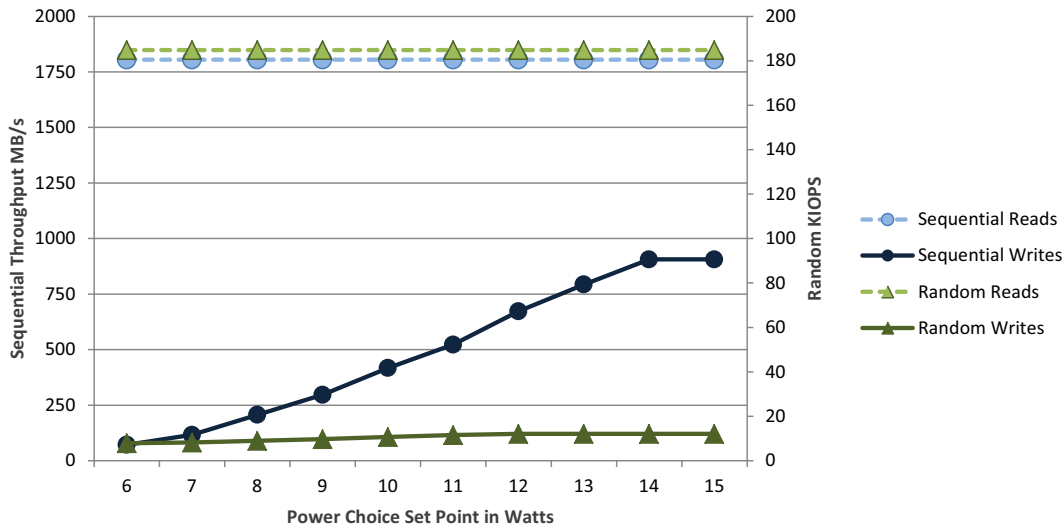


Figure 14. 1920GB Scalable Endurance: Performance vs Power Limit Settings IOPs chart

### 6.2.3 Current profiles

The +12V and +5V current profiles for the Seagate 1200.2 SAS SSD 2.5" drives are shown below.

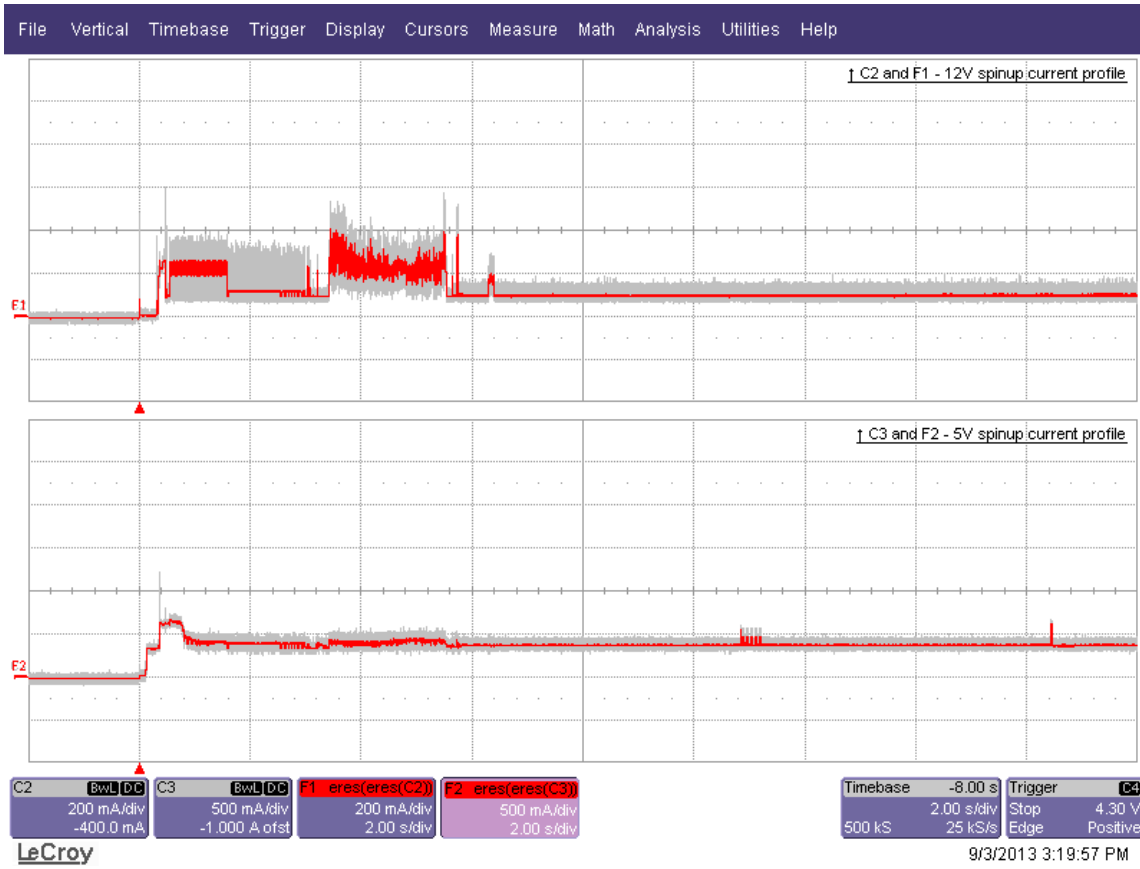


Figure 15. Current profiles for 800GB standard and 400GB High Endurance models



Figure 16. Current profiles for 400GB standard and 200GB high endurance models

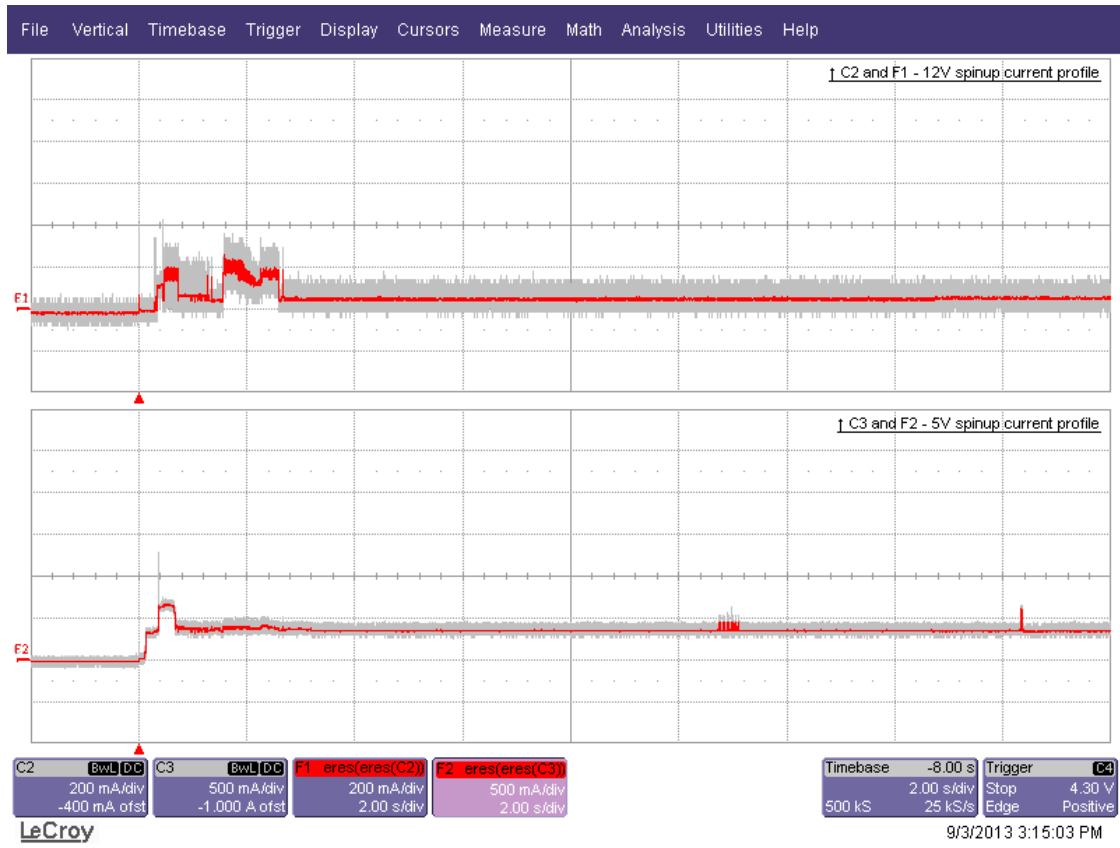


Figure 17. Current profiles for 200GB standard and 100GB high endurance models

## 6.3 Environmental limits

Temperature and humidity values experienced by the drive must be such that condensation does not occur on any drive part. Altitude and atmospheric pressure specifications are referenced to a standard day at 58.7°F (14.8°C). Maximum wet bulb temperature is 84.2°F (29°C).

**Note.** To maintain optimal performance drives should be run at nominal case temperatures.

### 6.3.1 Temperature

#### a. Operating

The drive meets the operating specifications over a 32°F to 167°F (0°C to 70°C) drive internal temperature range with a maximum temperature gradient of 36°F (20°C) per hour.

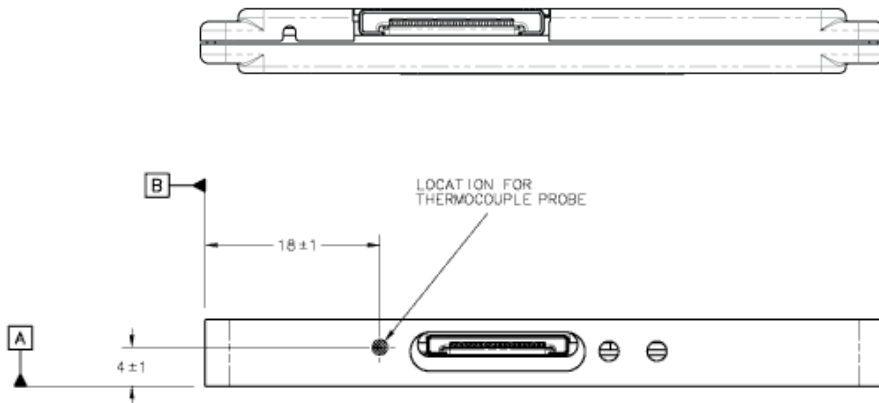
The maximum allowable drive internal temperature is 70°C. If the enclosure environment is unable to keep the internal temperature below this value the drive will reduce write activity to avoid over temperature condition. When the internal temperature is equal or greater than 65°C the drive will issue a SMART thermal warning.

The MTBF specification for the drive assumes the operating environment is designed to maintain nominal internal temperature. The rated MTBF is based upon a sustained internal temperature of 122°F (50°C). Occasional excursions in operating temperature between the rated MTBF temperature and the maximum drive operating internal temperature may occur without impact to the rated MTBF temperature. However continual or sustained operation at internal temperatures beyond the rated MTBF temperature will degrade the drive MTBF and reduce product reliability.

Air flow may be required to achieve consistent nominal internal temperature values (see Section 6.3). To confirm that the required cooling is provided, place the drive in its final mechanical configuration, and perform random write/read operations. After the temperatures stabilize, read the internal temperature of the drive using Seagate SeaChest or SeaTools utilities available at [www.seagate.com](http://www.seagate.com). See Figures below for temperature checkpoint.

#### b. Non-operating

–40° to 167°F (–40° to 75°C) package ambient with a maximum gradient of 36°F (20°C) per hour. This specification assumes that the drive is packaged in the shipping container designed by Seagate for use with drive.





### 6.3.2 Relative humidity

The values below assume that no condensation on the drive occurs.

- a. Operating  
5% to 95% non-condensing relative humidity with a maximum gradient of 20% per hour.
- b. Non-operating  
5% to 95% non-condensing relative humidity.

### 6.3.3 Effective altitude (sea level)

- a. Operating  
–1000 to +10,000 feet (–304.8 to +3048 meters)
- b. Non-operating  
–1000 to +40,000 feet (–304.8 to +12,192 meters)

### 6.3.4 Shock and vibration

Shock and vibration limits specified in this document are measured directly on the drive chassis. If the drive is installed in an enclosure to which the stated shock and/or vibration criteria is applied, resonances may occur internally to the enclosure resulting in drive movement in excess of the stated limits. If this situation is apparent, it may be necessary to modify the enclosure to minimize drive movement.

The limits of shock and vibration defined within this document are specified with the drive mounted by any of the four methods shown in Figure 18, and in accordance with the restrictions of Section 10.3.

#### 6.3.4.1 Shock

- a. Operating—normal  
The drive, as installed for normal operation, shall operate error free while subjected to intermittent shock not exceeding:
  - 1000 Gs at a maximum duration of 0.5ms (half sinewave)

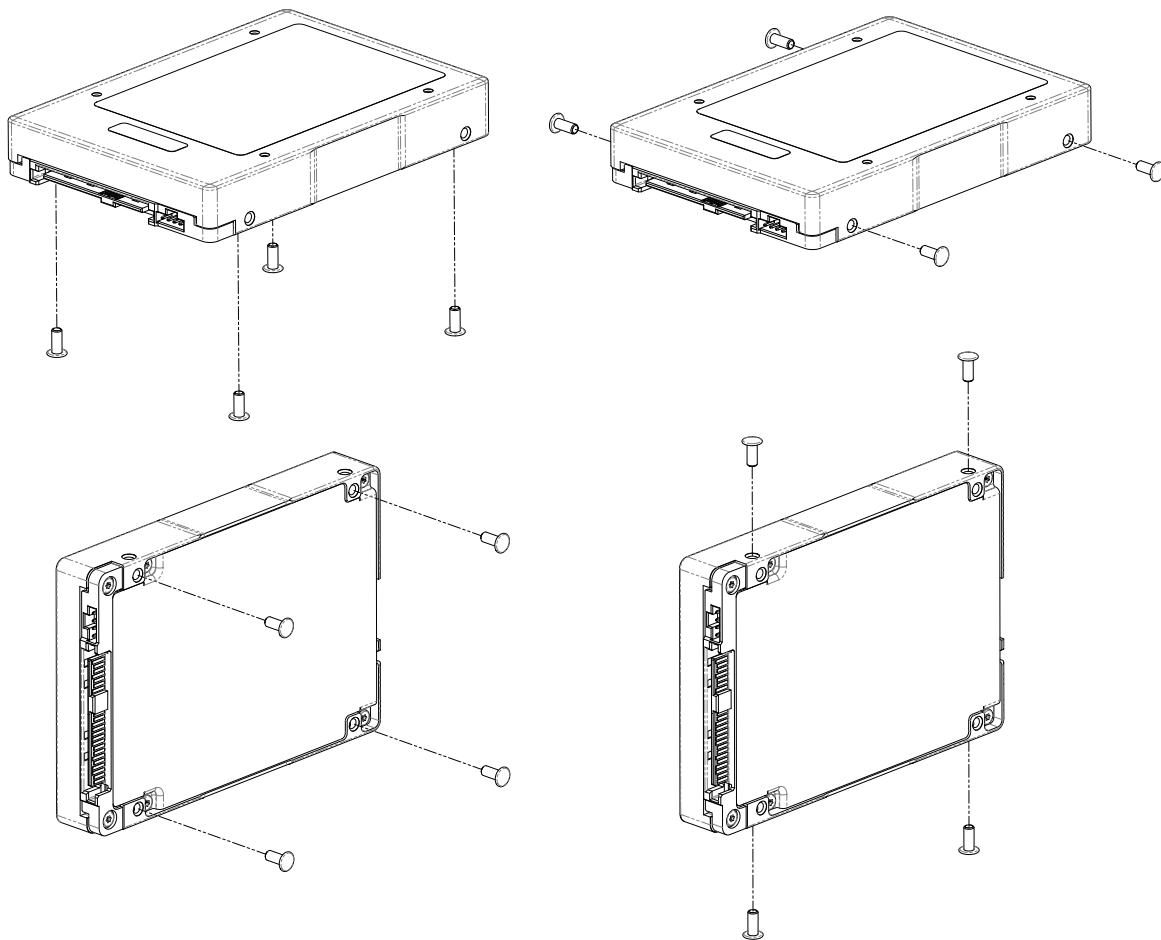
Shock may be applied in the X, Y, or Z axis. Shock is not to be repeated more than once every 2 seconds.

**Note.** This specification does not cover connection issues that may result from testing at this level.

- b. Non-operating  
The limits of non-operating shock shall apply to all conditions of handling and transportation. This includes both isolated drives and integrated drives.  
The drive subjected to nonrepetitive shock not exceeding the three values below, shall not exhibit device damage or performance degradation.
  - 1000 Gs at a maximum duration of 0.5ms (half sinewave)

Shock may be applied in the X, Y, or Z axis.

- c. Packaged  
Seagate finished drive bulk packs are designed and tested to meet or exceed applicable ISTA and ASTM standards. Volume finished drives will be shipped from Seagate factories on pallets to minimize freight costs and ease material handling. Seagate finished drive bulk packs may be shipped individually. For less than full shipments, instructions are printed on the bulk pack carton for minimum drive quantities and proper drive placement.



**Figure 18. Recommended mounting**

**Note.** Image may not represent actual product, for reference only.

#### 6.3.4.2 Vibration

##### a. Operating—normal

The drive as installed for normal operation, shall comply with the complete specified performance while subjected to vibration: Vibration may be applied in the X, Y, or Z axis.

Operating normal translational random shaped profile

20 - 2000 Hz 11.08 GRMS

**Note.** This specification does not cover connection issues that may result from testing at this level.

##### b. Operating—abnormal

Equipment as installed for normal operation shall not incur physical damage while subjected to periodic vibration:

Vibration occurring at these levels may degrade operational performance during the abnormal vibration period. Specified operational performance will continue when normal operating vibration levels are resumed. This assumes system recovery routines are available.

Operating abnormal translational random shaped profile

20 - 2000 Hz 11.08 GRMS

**Note.** This specification does not cover connection issues that may result from testing at this level.

c. Non-operating

The limits of non-operating vibration shall apply to all conditions of handling and transportation. This includes both isolated drives and integrated drives.

The drive shall not incur physical damage or degraded performance as a result of vibration.

Vibration may be applied in the X, Y, or Z axis.

Non-operating translational random shaped profile

20 - 2000 Hz

11.08 GRMS

### 6.3.5 Air cleanliness

The drive is designed to operate in a typical office environment with minimal environmental control.

### 6.3.6 Corrosive environment

Seagate electronic drive components pass accelerated corrosion testing equivalent to 10 years exposure to light industrial environments containing sulfurous gases, chlorine and nitric oxide, classes G and H per ASTM B845. However, this accelerated testing cannot duplicate every potential application environment.

Users should use caution exposing any electronic components to uncontrolled chemical pollutants and corrosive chemicals as electronic drive component reliability can be affected by the installation environment. The silver, copper, nickel and gold films used in Seagate products are especially sensitive to the presence of sulfide, chloride, and nitrate contaminants. Sulfur is found to be the most damaging. Materials used in cabinet fabrication, such as vulcanized rubber, that can outgas corrosive compounds should be minimized or eliminated. The useful life of any electronic equipment may be extended by replacing materials near circuitry with sulfide-free alternatives.

Seagate recommends that data centers be kept clean by monitoring and controlling the dust and gaseous contamination. Gaseous contamination should be within ANSI/ISA S71.04-2013 G2 classification levels (as measured on copper and silver coupons), and dust contamination to ISO 14644-1 Class 8 standards, and MTBF rated conditions as defined in the Annualized Failure Rate (AFR) and Mean Time Between Failure (MTBF) section.

### 6.3.7 Electromagnetic susceptibility

See Section 2.2.1.1.

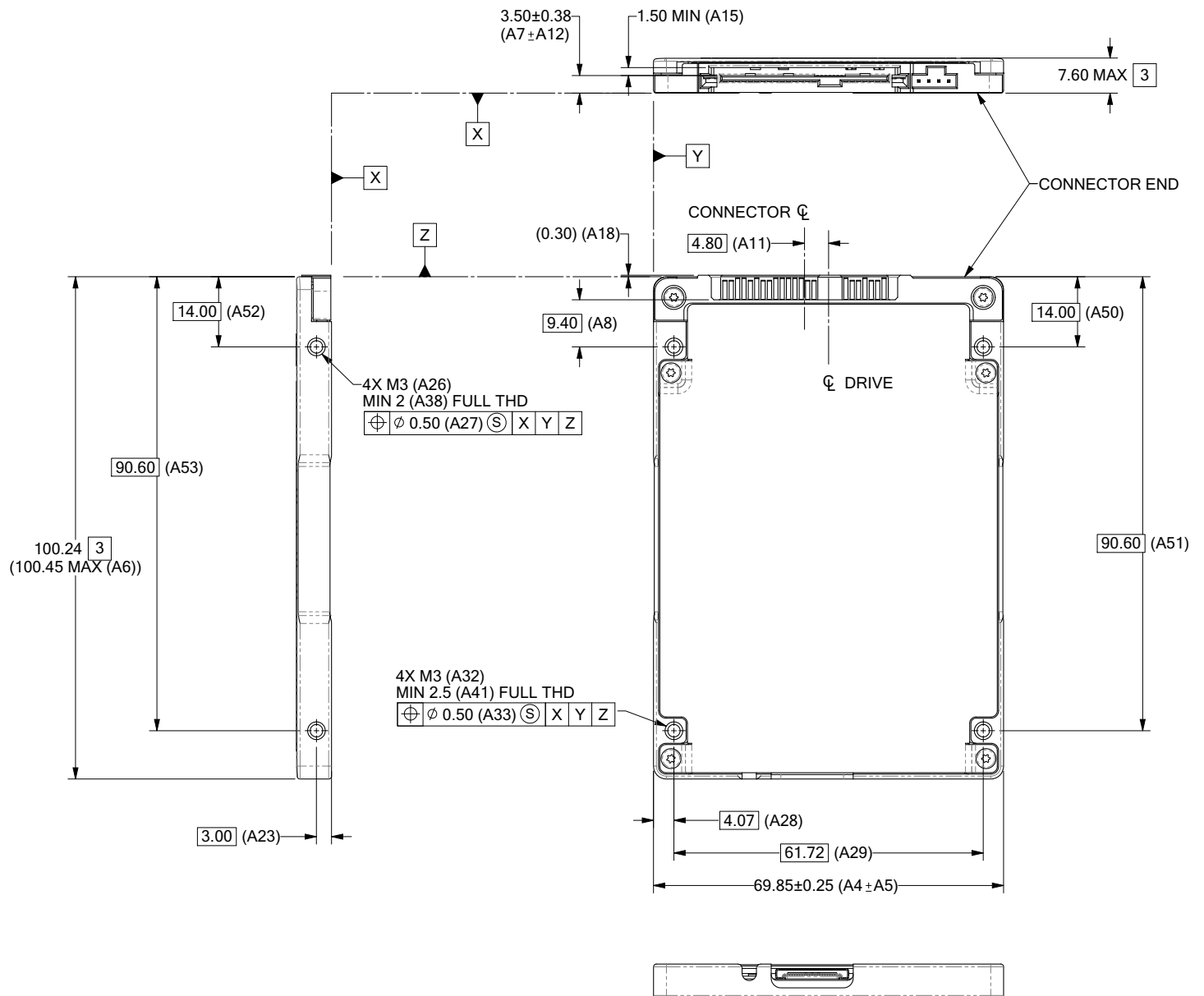
### 6.4 Mechanical specifications

Refer to Figures 19 and 20 for detailed mounting configuration dimensions. See Section 10.3, "Drive mounting."

**Weight:**

2.5" models      0.220 pounds      100 grams

**Note.** All (AXX) References (except where noted by [3]) are from *SFF-8201 Specification For 2.5" Form Factor Drives Dimension Rev 3.3, AUGUST 30 2014*, or from *SFF-8223 Specification Rev 2.7, AUGUST 30, 2014*. You can find these documents at: [www.sffcommittee.org](http://www.sffcommittee.org).



**Figure 19. Mounting configuration dimensions (2.5" - 7mm models)**

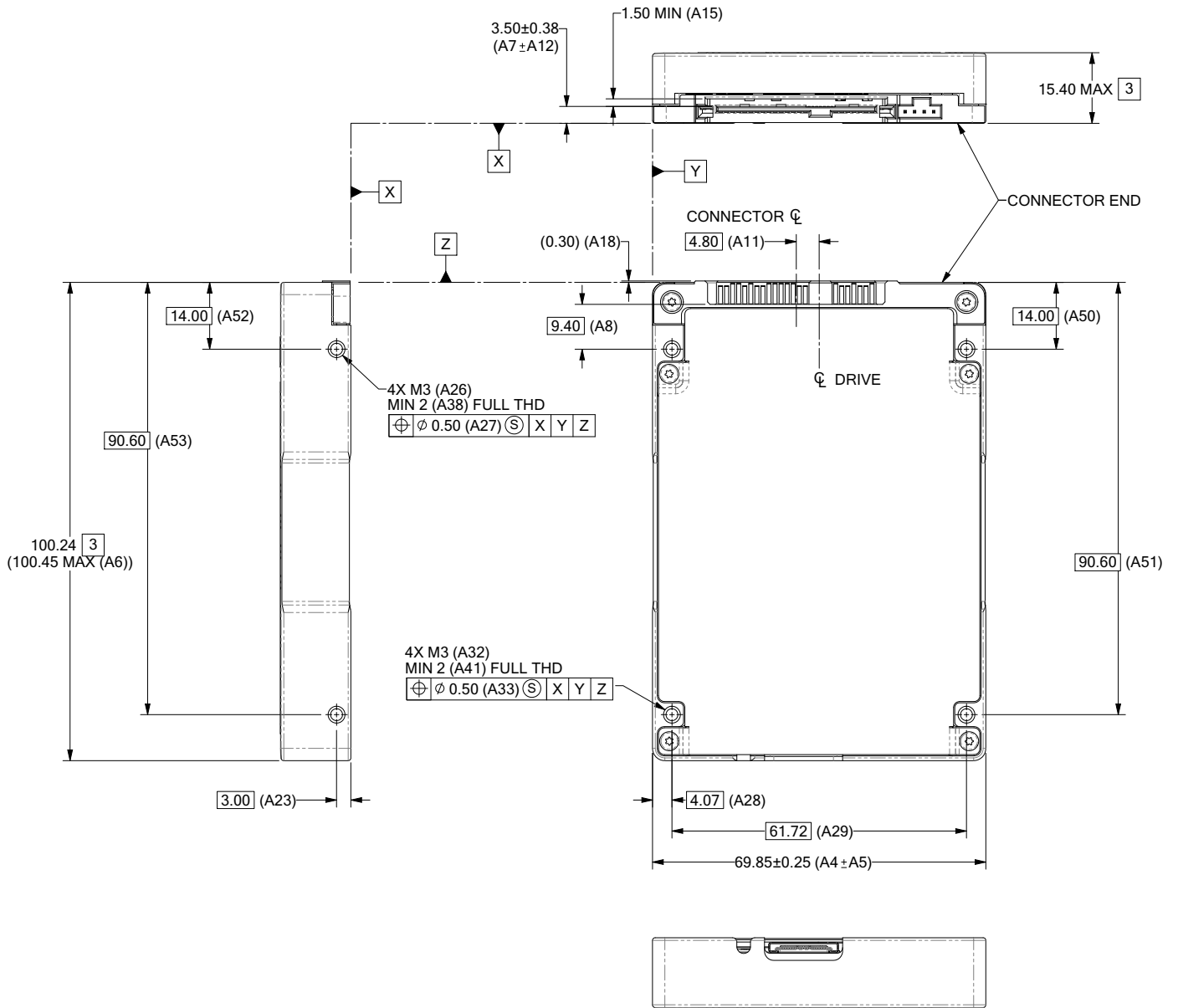


Figure 20. Mounting configuration dimensions (2.5" - 15mm models)

## 7.0 About FIPS

The Federal Information Processing Standard (FIPS) Publication 140-2 is a U.S. Government Computer Security Standard used to accredit cryptographic modules. It is titled 'Security Requirements for Cryptographic Modules (FIPS PUB 140-2)' and is issued by the National Institute of Standards and Technology (NIST).

### 7.1 Purpose

This standard specifies the security requirements that will be satisfied by a cryptographic module utilized within a security system protecting sensitive but unclassified information. The standard provides four increasing, qualitative levels of security: Level 1, Level 2, Level 3 and Level 4. These levels are intended to cover the wide range of potential applications and environments in which cryptographic modules may be employed.

### 7.2 Validation Program

Products that claim conformance to this standard are validated by the Cryptographic Module Validation Program (CMVP) which is a joint effort between National Institute of Standards and Technology (NIST) and the Communications Security Establishment (CSE) of the Government of Canada. Products validated as conforming to FIPS 140-2 are accepted by the Federal agencies of both countries for the protection of sensitive information (United States) or Designated Information (Canada).

In the CMVP, vendors of cryptographic modules use independent, accredited testing laboratories to have their modules tested. National Voluntary Laboratory Accreditation Program (NVLAP) accredited laboratories perform cryptographic module compliance/conformance testing.

### 7.3 Seagate Enterprise SED

The SEDs referenced in this Product Manual have been validated by CMVP and have been thoroughly tested by a NVLAP accredited lab to satisfy FIPS 140-2 Level 2 requirements. In order to operate in FIPS Approved Mode of Operation, these SEDs require security initialization. For more information, refer to 'Security Rules' section in the 'Security Policy' document uploaded on the NIST website. To reference the product certification visit: <http://csrc.nist.gov/groups/STM/cmvp/documents/140-1/1401vend.htm>, and search for "Seagate".

## 7.4 Security Level 2

Security Level 2 enhances the physical security mechanisms of a Security Level 1 cryptographic module by adding the requirement for tamper-evidence, which includes the use of tamper-evident coatings or seals on removable covers of the module. Tamper-evident coatings or seals are placed on a cryptographic module so that the coating or seal must be broken to attain physical access to the critical security parameters (CSP) within the module. Tamper-evident seals (example shown in Figure 21, page 54) are placed on covers to protect against unauthorized physical access. In addition Security Level 2 requires, at a minimum, role-based authentication in which a cryptographic module authenticates the authorization of an operator to assume a specific role and perform a corresponding set of services.



**Figure 21.** Example of FIPS tamper evidence labels.

**Note.** Image is for reference only, may not represent actual drive.

## 8.0 About self-encrypting drives

Self-encrypting drives (SEDs) offer encryption and security services for the protection of stored data, commonly known as "protection of data at rest." These drives are compliant with the Trusted Computing Group (TCG) Enterprise Storage Specifications as detailed in Section 2.3.

The Trusted Computing Group (TCG) is an organization sponsored and operated by companies in the computer, storage and digital communications industry. The Seagate SED models comply with the standards published by the TCG.

To use the security features in the drive, the host must be capable of constructing and issuing the following two SCSI commands:

- SECURITY PROTOCOL OUT
- SECURITY PROTOCOL IN

These commands are used to convey the TCG protocol to and from the drive in the appropriate command payloads.

### 8.1 Data encryption

Encrypting drives use one in-line encryption engine for each port, employing AES-256 data encryption in Cipher Block Chaining (CBC) mode to encrypt all data prior to being written on the media and to decrypt all data as it is read from the media. The encryption engines are always in operation and cannot be disabled.

The 32-byte Data Encryption Key (DEK) is a random number which is generated by the drive, never leaves the drive, and is inaccessible to the host system. The DEK is itself encrypted when it is stored on the media and when it is in volatile temporary storage (DRAM) external to the encryption engine. A unique data encryption key is used for each of the drive's possible 16 data bands (see Section 8.5).

### 8.2 Controlled access

The drive has two security providers (SPs) called the "Admin SP" and the "Locking SP." These act as gatekeepers to the drive security services. Security-related commands will not be accepted unless they also supply the correct credentials to prove the requester is authorized to perform the command.

#### 8.2.1 Admin SP

The Admin SP allows the drive's owner to enable or disable firmware download operations (see Section 8.4). Access to the Admin SP is available using the SID (Secure ID) password or the MSID (Manufacturers Secure ID) password.

#### 8.2.2 Locking SP

The Locking SP controls read/write access to the media and the cryptographic erase feature. Access to the Locking SP is available using the BandMasterX or EraseMaster passwords. Since the drive owner can define up to 16 data bands on the drive, each data band has its own password called BandMasterX where X is the number of the data band (0 through 15).

#### 8.2.3 Default password

When the drive is shipped from the factory, all passwords are set to the value of MSID. This 32-byte random value can only be read by the host electronically over the interface. After receipt of the drive, it is the responsibility of the owner to use the default MSID password as the authority to change all other passwords to unique owner-specified values.

### 8.3 Random number generator (RNG)

The drive has a 32-byte hardware RNG that it uses to derive encryption keys or, if requested to do so, to provide random numbers to the host for system use, including using these numbers as Authentication Keys (passwords) for the drive's Admin and Locking SPs.



## 8.4 Drive locking

In addition to changing the passwords, as described in Section 8.2.3, the owner should also set the data access controls for the individual bands.

The variable "LockOnReset" should be set to "PowerCycle" to ensure that the data bands will be locked if power is lost. In addition "ReadLockEnabled" and "WriteLockEnabled" must be set to true in the locking table in order for the bands "LockOnReset" setting of "PowerCycle" to actually lock access to the band when a "PowerCycle" event occurs. This scenario occurs if the drive is removed from its cabinet. The drive will not honor any data READ or WRITE requests until the bands have been unlocked. This prevents the user data from being accessed without the appropriate credentials when the drive has been removed from its cabinet and installed in another system.

When the drive is shipped from the factory, the firmware download port is unlocked allowing the drive to accept any attempt to download new firmware. The drive owner must use the SID credential to lock the firmware download port before firmware updates will be rejected.

## 8.5 Data bands

When shipped from the factory, the drive is configured with a single data band called Band 0 (also known as the Global Data Band) which comprises LBA 0 through LBA max. The host may allocate Band1 by specifying a start LBA and an LBA range. The real estate for this band is taken from the Global Band. An additional 14 Data Bands may be defined in a similar way (Band2 through Band15) but before these bands can be allocated LBA space, they must first be individually enabled using the EraseMaster password.

Data bands cannot overlap but they can be sequential with one band ending at LBA (x) and the next beginning at LBA (x+1).

Each data band has its own drive-generated encryption key and its own user-supplied password. The host may change the Encryption Key (see Section 8.6) or the password when required. The bands shall be aligned to 4KB LBA boundaries.

## 8.6 Cryptographic erase

A significant feature of SEDs is the ability to perform a cryptographic erase. This involves the host telling the drive to change the data encryption key for a particular band. Once changed, the data is no longer recoverable since it was written with one key and will be read using a different key. Since the drive overwrites the old key with the new one, and keeps no history of key changes, the user data can never be recovered. This is tantamount to an instantaneous data erase and is very useful if the drive is to be scrapped or repositioned.

## 8.7 Authenticated firmware download

In addition to providing a locking mechanism to prevent unwanted firmware download attempts, the drive also only accepts download files which have been cryptographically signed by the appropriate Seagate Design Center.

Three conditions must be met before the drive will allow the download operation:

1. The download must be an SED file. A standard (base) drive (non-SED) file will be rejected.
2. The download file must be signed and authenticated.
3. As with a non-SED drive, the download file must pass the acceptance criteria for the drive. For example it must be applicable to the correct drive model, and have compatible revision and customer status.

## 8.8 Power requirements

The standard drive models and the SED drive models have identical hardware, however the security and encryption portion of the drive controller ASIC is enabled and functional in the SED models. This represents a small additional drain on the 5V supply of about 30mA and a commensurate increase of about 150mW in power consumption. There is no additional drain on the 12V supply. See the tables in Section 6.2.1 for power requirements on the standard (non-SED) drive models.

## 8.9 Supported commands

The SED models support the following two commands in addition to the commands supported by the standard (non-SED) models as listed in Table 18:

- SECURITY PROTOCOL OUT (B5h)
- SECURITY PROTOCOL IN (A2h)

## 8.10 Sanitize - Cryptographic Erase

This command cryptographically erases all user data on the drive by destroying the current data encryption key and replacing it with a new data encryption key randomly generated by the drive. Sanitize CRYPTOGRAPHIC ERASE is a SCSI CDB Op code 48h and selecting the service action code 3 (CRYPTOGRAPHIC ERASE).

## 8.11 RevertSP

SED models will support the RevertSP feature which erases all data in all bands on the device and returns the contents of all SPs (Security Providers) on the device to their original factory state. In order to execute the RevertSP method the unique PSID (Physical Secure ID) printed on the drive label must be provided. PSID is not electronically accessible and can only be manually read from the drive label or scanned in via the 2D barcode.

## 9.0 Defect and error management

Seagate continues to use innovative technologies to manage defects and errors. These technologies are designed to increase data integrity, perform drive self-maintenance, and validate proper drive operation.

SCSI defect and error management involves drive internal defect/error management and SAS system error considerations (errors in communications between the initiator and the drive). In addition, Seagate provides the following technologies used to increase data integrity and drive reliability:

- Auto-Reallocation (see Section 9.4)

The read error rates and specified storage capacities are not dependent on host (initiator) defect management routines.

### 9.1 Drive internal defects/errors

During the initial drive manufacturing test operation at the factory, media defects are identified, tagged as being unusable, and their locations recorded on the drive primary defects list (referred to as the “P” list). At factory format time, these known defects are also deallocated, that is, marked as retired and the location listed in the defects reallocation table. The “P” list is not altered after factory formatting. Locations of defects found and reallocated during error recovery procedures after drive shipment are listed in the “G” list (defects growth list). The “P” and “G” lists may be referenced by the initiator using the READ DEFECT DATA command.

Details of the SCSI commands supported by the drive are described in the *SAS Interface Manual*. Also, more information on the drive Error Recovery philosophy is presented in the *SAS Interface Manual*.

The drive uses a vendor unique format to report defects via the READ DEFECT DATA command pending T10 standardization of a format for Solid State Devices. This format defect type is defined as 110b in the SCSI FORMAT UNIT command. The definition of the 110b format is defined in the following table.

**Table 15 SSD Physical format address descriptor**

Bit Byte	7	6	5	4	3	2	1	0
0	(MSB) MEDIA ID (LSB)							
1								
2	CHANNEL							
3	DIE							
4	(MSB) BLOCK (LSB)							
5								
6	RESERVED							
7	VENDOR UNIQUE							

The MEDIA ID field contains an identifier for the flash controller for devices that utilize more than one flash controller.

The CHANNEL field contains the channel number within the corresponding Flash Controller.

The DIE field contains the die number within channel.

The BLOCK field contains the block number within the die.

The VENDOR UNIQUE field may contain vendor unique information.

## 9.2 Drive error recovery procedures

When an error occurs during drive operation, the drive performs error recovery procedures to attempt to recover the data. The error recovery procedures used are not user changeable.

## 9.3 SAS system errors

Information on the reporting of operational errors across the interface is given in the *SAS Interface Manual*. The SSP Response returns information to the host about numerous kinds of errors. The Receive Diagnostic Results reports the results of diagnostic operations performed by the drive.

Status returned by the drive to the initiator is described in the *SAS Interface Manual*. Status reporting plays a role in systems error management and its use in that respect is described in sections where the various commands are discussed.

## 9.4 Auto-Reallocation

Auto-Reallocation allows the drive to reallocate unreadable locations on a subsequent write command if the recovery process deems the location to be defective. The drive performs auto-reallocation on every WRITE command. With each write to a Logical LBA, the drive writes the data to a different physical media location. Physical locations that return unrecoverable errors are retired during future WRITE attempts and associated recovery process.

This is in contrast to the system having to use the REASSIGN BLOCKS command to reassign a location that was unreadable and then generate a WRITE command to rewrite the data. This operation requires that AWRE and ARRE are enabled—this is the default setting from the Seagate factory.

## 9.5 Protection Information (PI)

Protection Information is intended as a standardized approach to system level LRC traditionally provided by systems using 520 byte formatted LBAs. Drives formatted with PI information provide the same, common LBA count (i.e. same capacity point) as non-PI formatted drives. Sequential performance of a PI drive will be reduced by approximately 1.56% due to the extra overhead of PI being transferred from the media that is not calculated as part of the data transferred to the host. To determine the full transfer rate of a PI drive, transfers should be calculated by adding the 8 extra bytes of PI to the transferred LBA length, i.e.  $512 + 8 = 520$ . PI

formatted drives are physically formatted to 520 byte LBA's that store 512 bytes of customer data with 8 bytes of Protection Information appended to it. The advantage of PI is that the Protection Information bits can be managed at the HBA and HBA driver level. Allowing a system that typically does not support 520 LBA formats to integrate this level of protection.

Protection Information is valid with any supported LBA size, except 528. 512 LBA size is used here as common example.

### 9.5.1 Levels of PI

There are 4 types of Protection Information.

**Type 0** - Describes a drive that is not formatted with PI information bytes. This allows for legacy support in non-PI systems.

**Type 1** - Provides support of PI protection using 10 and 16 byte commands. The RDPROTECT and WRTPROTECT bits allow for checking control through the CDB. Eight bytes of Protection Information are transmitted at LBA boundaries across the interface if RDPROTECT and WRTPROTECT bits are nonzero values. Type 1 does not allow the use of 32 byte commands.

**Type 2** - Provides checking control and additional expected fields within the 32 byte CDBs. Eight bytes of Protection Information are transmitted at LBA boundaries across the interface if RDPROTECT and WRTPROTECT bits are nonzero values. Type 2 does allow the use of 10 and 16 byte commands with zero values in the RDPROTECT and WRTPROTECT fields. The drive will generate 8 bytes of Protection Information (e.g. 0xFFFFFFFF) to be stored on the media, but the 8 bytes will not be transferred to the host during a READ command.

**Type 3** - Seagate products do not support Type 3.

### 9.5.2 Setting and determining the current Type Level

A drive is initialized to a type of PI by using the FORMAT UNIT command on a PI capable drive. Once a drive is formatted to a PI Type, it may be queried by a READ CAPACITY (16) command to report the PI type which it is currently formatted to. A drive can only be formatted to a single PI Type. It can be changed at anytime to a new Type but requires a FORMAT UNIT command which destroys all existing data on the drive. No other vehicle for changing the PI type is provided by the T10 SBC3 specification.

Type 1 PI FORMAT UNIT CDB command: 04 90 00 00 00 00, parameter data: 00 A0 00 00

Type 2 PI FORMAT UNIT CDB command: 04 D0 00 00 00 00, parameter data: 00 A0 00 00

### 9.5.3 Identifying a Protection Information drive

The Standard INQUIRY data provides a bit to indicate if PI is support by the drive. Vital Product Descriptor (VPD) page 0x86 provides bits to indicate the PI Types supported and which PI fields the drive supports checking.

**Note.** For further details with respect to PI, please refer to SCSI Block Commands - 3 (SBC-3) Draft Standard documentation.

## 10.0 Installation

Seagate 1200.2 SAS SSD drive installation is a plug-and-play process. There are no jumpers on the drive.

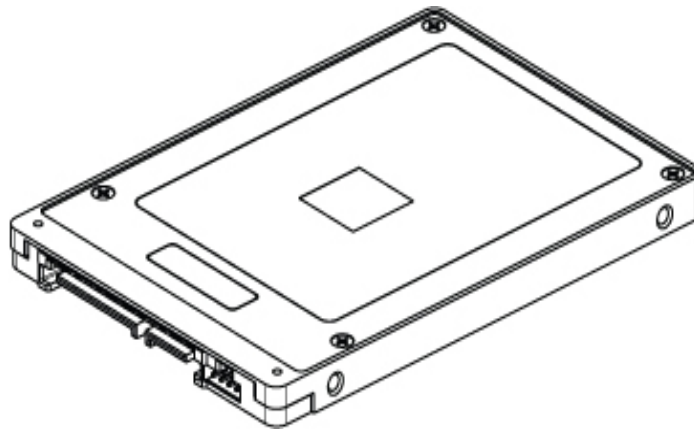
SAS drives are designed to be used in a host system that provides a SAS-compatible backplane with bays designed to accommodate the drive. In such systems, the host system typically provides a carrier or tray into which the drive must be mounted. Mount the drive to the carrier or tray provided by the host system using four M3 x 0.5 metric screws. When tightening the screws, use a maximum torque of 4.5 in-lb +/- 0.45 in-lb. Do not over-tighten or force the screws. The drive can be mounted in any orientation.

**Note.** SAS drives are designed to be attached to the host system without I/O or power cables. If the intent is to use the drive in a non-backplane host system, connecting the drive using high-quality cables is acceptable as long as the I/O cable length does not exceed 10 meters (32.8 feet).

Slide the carrier or tray into the appropriate bay in the host system using the instructions provided by the host system. This connects the drive directly to the system's SAS connector. The SAS connector is normally located on a SAS backpanel. See Section 11.4.1 for additional information about these connectors.

Power is supplied through the SAS connector.

The drive is shipped from the factory low-level formatted in 512-byte logical blocks. Reformatting the drive is only required if the application requires a different logical block size.



**Figure 22.** Physical interface

### 10.1 Drive orientation

The drive may be mounted in any orientation. All drive performance characterizations, however, have been done with the drive in horizontal (level) and vertical (drive on its side) orientations, which are the two preferred mounting orientations.

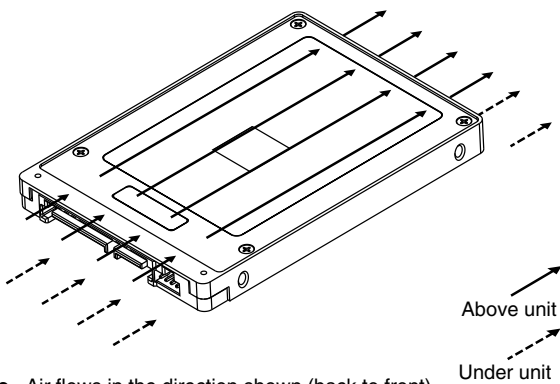
### 10.2 Cooling

Cabinet cooling must be designed by the customer so that the temperature of the drive will not exceed temperature conditions specified in Section 6.3.1, "Temperature."

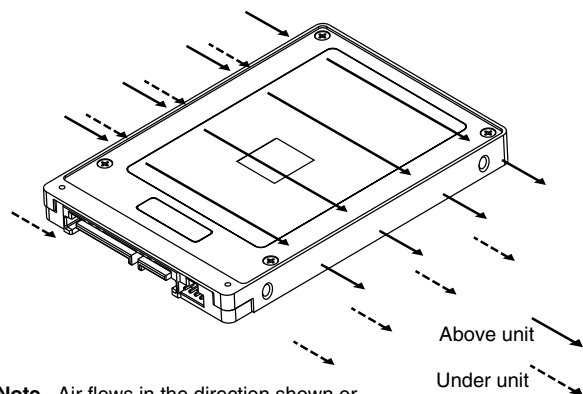
The rack, cabinet, or drawer environment for the drive must provide heat removal from the assembly. The system designer should confirm that adequate heat removal is provided using the temperature measurement guidelines described in Section 6.3.1.

Forced air flow may be required to keep temperatures at or below the temperatures specified in Section 6.3.1 in which case the drive should be oriented, or air flow directed, so that the least amount of air flow resistance is created while providing air flow. Also, the shortest possible path between the air inlet and exit should be chosen to minimize the travel length of air heated by the drive and other heat sources within the rack, cabinet, or drawer environment.

If forced air is determined to be necessary, possible air-flow patterns are shown in Figure 23. The air-flow patterns are created by one or more fans, either forcing or drawing air as shown in the illustrations. Conduction, convection, or other forced air-flow patterns are acceptable as long as the temperature measurement guidelines of Section 6.3.1 are met.



**Note.** Air flows in the direction shown (back to front) or in reverse direction (front to back)



**Note.** Air flows in the direction shown or in reverse direction (side to side)

**Figure 23. Air flow**

**Note.** Image may not represent actual product, for reference only.

### 10.3 Drive mounting

Mount the drive using the bottom or side mounting holes. If mounting the drive using the bottom holes, ensure not to physically distort the drive by attempting to mount it on a stiff, non-flat surface.

The allowable mounting surface stiffness is 80 lb/in (14.0 N/mm). The following equation and paragraph define the allowable mounting surface stiffness:

$$K \times X = F < 15\text{lb} = 67\text{N}$$

where K is the mounting surface stiffness (units in lb/in or N/mm) and X is the out-of-plane surface distortion (units in inches or millimeters). The out-of-plane distortion (X) is determined by defining a plane with three of the four mounting points fixed and evaluating the out-of-plane deflection of the fourth mounting point when a known force (F) is applied to the fourth point.

## 10.4 Grounding

Signal ground (PCBA) and case ground are connected together in the drive and cannot be separated by the user. The equipment in which the drive is mounted is connected directly to the drive with no electrically isolating shock mounts. If it is desired for the system chassis to not be connected to the drive ground, the systems integrator or user must provide a nonconductive (electrically isolating) method of mounting the drive in the host equipment.

Increased radiated emissions may result if designers do not provide the maximum surface area ground connection between system ground and drive ground. This is the system designer's and integrator's responsibility.



## 11.0 Interface requirements

This section partially describes the interface requirements as implemented on Seagate 1200.2 SAS SSD drives. Additional information is provided in the *SAS Interface Manual* (part number 100293071).

### 11.1 SAS features

This section lists the SAS-specific features supported by Seagate 1200.2 SAS SSD drives.

#### 11.1.1 Task management functions

Table 16 lists the SAS task management functions supported.

**Table 16 SAS task management functions supported**

Task name	Supported
Abort Task	Yes
Abort task set	Yes
Clear ACA	Yes
Clear task set	Yes
L_T Nexus Reset	Yes
Logical Unit Reset	Yes
Query Task	Yes
Query Task Set	Yes
Query Asynchronous Event	Yes

#### 11.1.2 Task management responses

Table 17 lists the SAS response codes returned for task management functions supported.

**Table 17 Task management response codes**

Function name	Response code
Function complete	00
Invalid frame	02
Function not supported	04
Function failed	05
Function succeeded	08
Invalid logical unit	09

## 11.2 Dual port support

Seagate 1200.2 SAS SSD SAS drives have two independent ports. These ports may be connected in the same or different SCSI domains. Each drive port has a unique SAS address. The two ports have the capability of independent port clocking (e.g. both ports can run at 12Gb/s or the first port can run at 12Gb/s while the second port runs at 6Gb/s.) The supported link rates are 1.5, 3.0, 6.0 or 12.0 Gb/s. Subject to buffer availability, the Seagate 1200.2 SAS SSD drives support:

- Concurrent port transfers—The drive supports receiving COMMAND, TASK management transfers on both ports at the same time.
- Full duplex—The drive supports sending XFER\_RDY, DATA and RESPONSE transfers while receiving frames on both ports.

### 11.3 SCSI commands supported

Table 18 lists the SCSI commands supported by Seagate 1200.2 SAS SSD drives. For details about command fields definition and options, refer to the Seagate document *SCSI Commands Reference Manual, 100293068 Rev. H.pdf* available on the SAS1200.2 product page at Seagate.com.

**Table 18 Supported commands**

Command name	Command code	Supported [4]
CHANGE DEFINITION	40h	N
FORMAT UNIT [1]	04h	Y
DPRY bit supported		N
DCRT bit supported		Y
STPF bit supported		Y
IP bit supported		Y
DSP bit supported		Y
IMMED bit supported		Y
VS (vendor specific)		N
INQUIRY	12h	Y
Block Limits page (B0h)		Y
Block Device Characteristics page (B1h)		Y
Date Code page (C1h)		Y
Device Behavior page (C3h)		Y
Device Identification page (83h)		Y
Extended Inquiry Data page (86h)		Y
Firmware Numbers page (C0h)		Y
Jumper Settings page (C2h)		N
Power Conditions page (8Ah/00h)		Y
Power Consumption page (8Dh)		Y
Power Consumption page (1AH/01h)		Y
Supported Vital Product Data page (00h)		Y
Thin Provisioning page (B2h)		Y
Unit Serial Number page (80h)		Y
Vendor Unique page (D1h)		Y
Vendor Unique page (D2h)		Y
LOG SELECT	4Ch	Y
PCR bit		Y
DU bit		N
DS bit		Y
TSD bit		Y
ETC bit		N
TMC bit		N

**Table 18 Supported commands (continued)**

Command name	Command code	Supported [4]
LP bit		N
LOG SENSE	4Dh	Y
Application Client Log page (0Fh)		Y
Background Scan Results log page (15h)		Y
Buffer Over-run/Under-run page (01h)		N
Cache Statistics page (37h)		Y
Factory Log page (3Eh)		Y
Information Exceptions Log page (2Fh)		Y
Last n Deferred Errors or Asynchronous Events page (0Bh)		N
Last n Error Events page (07h)		N
Non-medium Error page (06h)		Y
Pages Supported list (00h)		Y
Power Conditions Transitions page (1Ah)		Y
Protocol-Specific Port log pages (18h)		Y
Read Error Counter page (03h)		Y
Read Reverse Error Counter page (04h)		N
Self-test Results page (10h)		Y
Solid State Media log page (11h)		Y
Start-stop Cycle Counter page (0Eh)		Y
Temperature page (0Dh)		Y
Vendor Unique page (38h)		Y
Vendor Unique page (3Ch)		Y
Verify Error Counter page (05h)		Y
Write error counter page (02h)		Y
Mode Select (6) (Same Pages As Mode Sense (6))	15h	Y [3]
Mode Select (10) (Same Pages As Mode Sense (6))	55h	Y
Mode Sense (6)	1Ah	Y [3]
Caching Parameters page (08h)		Y
Control Mode page (0Ah)		Y
Disconnect/Reconnect (02h)		Y
Error Recovery page (01h)		Y
Format page (03h)		N
Information Exceptions Control page (1Ch)		Y
Background Scan mode subpage (1Ch/01h)		Y
Notch and Partition Page (0Ch)		N
Protocol-Specific LUN mode page (18h)		Y
Protocol-Specific Port page (19h)		Y
Phy Control and Discover subpage (19h/01h)		Y

**Table 18 Supported commands (continued)**

Command name	Command code	Supported [4]
Enhanced Phy Control subpage (19h/03h)		Y
Power Condition page (1A/00h)		Y
Power Consumption page (1AH/01h)		Y
Rigid Disc Drive Geometry page (04h)		N
Unit Attention page (00h)		Y
Verify Error Recovery page (07h)		Y
Xor Control page (10h)		N
Mode Sense (10) (Same Pages As Mode Sense (6))	5Ah	Y
Persistent Reserve In	5Eh	Y
Read Full Status	5Eh/03h	Y
Read Keys	5Eh/00h	Y
Read Reservations	5Eh/001	Y
Read Capabilities	5Eh/02h	Y
Persistent Reserve Out	5Fh	Y
Clear	5Fh/03h	Y
Preempt	5Fh/04h	Y
Preempt And About	5Fh/05h	Y
Register	5Fh/00h	Y
Register and Ignore Existing Keys	5Fh/06h	Y
Register and Move	5Fh/07h	Y
Release	5Fh/02h	Y
Replace Lost Reservation	5Fh/08h	Y
Reserve	5Fh/01h	Y
Pre-fetch (10)	34h	N
Read (6)	08h	Y
Read (10)	28h	Y
DPO bit supported		Y
FUA bit supported		Y
Read (12)	A8h	N
Read (16)	88h	Y
Read (32)	7Fh/0009h	Y
Read Buffer (Modes 0, 2, 3, Ah And Bh Supported)	3Ch	Y (non-SED drives only)
Error history	3Ch/1Ch	Y
Read Capacity (10)	25h	Y
Read Capacity (16)	9Eh/10h	Y
Read Defect Data (10)	37h	Y
Read Defect Data (12)	B7h	Y
Read Long (10)	3Eh	Y (non-SED drives only)

**Table 18 Supported commands (continued)**

Command name	Command code	Supported [4]
Read Long (16)	9Eh/11h	Y (non-SED drives only)
Reassign Blocks	07h	Y
Receive Diagnostic Results	1Ch	Y
Supported Diagnostics pages (00h)		Y
Translate page (40h)		N
Release (6)	17h	Y
Release (10)	57h	Y
Report Identifying Information	A3h/05h	Y
Report LUNs	A0h	Y
Report Supported Operation Codes	A3h/0Ch	Y
Report Supported Task Management Functions	A3h/0Dh	Y
Request Sense	03h	Y
Actual Retry Count bytes		Y
Extended Sense		Y
Field Pointer bytes		Y
Reserve (6)	16h	Y
3rd Party Reserve		Y
Extent Reservation		N
Reserve (10)	56h	Y
3rd Party Reserve		Y
Extent Reservation		N
Rezero Unit	01h	Y
Sanitize	48h	Y
Overwrite	48h/01h	N
Block Erase	48h/02h	Y
Cryptographic Erase	48h/03h	Y (SED models only)
Exit Failure Mode	48h/1Fh	Y
Security Protocol In	A2h	Y (SED models only)
Security Protocol Out	B5h	Y (SED models only)
Seek (6)	0Bh	Y
Seek (10)	2Bh	Y
Send Diagnostics	1Dh	Y
Supported Diagnostics pages (00h)		Y
Translate page (40h)		N
Set Identifying Information	A4h/06h	Y
Set Timestamp	A4h/0Fh	Y
Start Unit/stop Unit	1Bh	Y
Synchronize Cache	35h	Y

**Table 18 Supported commands (continued)**

Command name	Command code	Supported [4]
Synchronize Cache (16)	91h	Y
Test Unit Ready	00h	Y
Unmap	42H	Y
Verify (10)	2Fh	Y
BYTCHK bit		Y
Verify (12)	AFh	N
Verify (16)	8Fh	Y
Verify (32)	7Fh/000Ah	Y
Write (6)	0Ah	Y
Write (10)	2Ah	Y
DPO bit		Y
FUA bit		Y
Write (12)	AAh	N
Write (16)	8Ah	Y
Write (32)	7Fh/000Bh	Y
Write And Verify (10)	2Eh	Y
DPO bit		Y
Write And Verify (12)	AEh	N
Write And Verify (16)	8Eh	Y
Write And Verify (32)	7Fh/000Ch	Y
Write Buffer (Modes 0, 2, Supported)	3Bh	Y (non-SED drives only)
Write Buffer	3Bh	
Download Application Log	3Bh/1Ch	Y
Firmware Download option (modes 5, 7, Ah and Bh) [2]		Y (non-SED drives only)
Firmware Download option (modes 4, 5, 7)		Y (SED drives only)
Write Long (10)	3Fh	Y
Write Long (16)	9Fh/11h	Y
Write Same (10)	41h	Y
PBdata		N
LBdata		N
Write Same (16)	93h	Y
Write Same (32)	7Fh/000Dh	Y
Xdread	52h	N
Xdwrite	50h	N
Xpwrite	51h	N

[1] Seagate 1200.2 SAS SSD drives can format to 512, 520, 524, 528, 4096, 4160, 4192 and 4224 bytes per logical block.

[2] **Warning.** Power loss during a firmware upgrade can result in firmware corruption. This usually makes the drive inoperable.

[3] Reference MODE SENSE command 1Ah for mode pages supported.

- [4] Y = Yes. Command is supported.  
 N = No. Command is not supported.  
 A = Support is available on special request.

### 11.3.1 INQUIRY data

Table 19 lists the INQUIRY command data that the drive should return to the initiator per the format given in the *SAS Interface Manual*.

**Table 19 Seagate 1200.2 SAS SSD INQUIRY data**

Bytes	Data (hex)																
0-15	00	00	xx**	12	8B	01	PP	02	53	45	41	47	41	54	45	20	Vendor ID
16-31	[53	54	33	38	34	30	46	4D	30	30	30	33}	20	20	20	20	Product ID
32-47	R#	R#	R#	R#	S#	S#	S#	S#	S#	S#	S#	S#	00	00	00	00	
48-63	00	00	00	00	00	00	00	00	00	00	00	00	00	00	00	00	
64-79	00	00	00	00	00	00	00	00	00	00	00	00	00	00	00	00	
80-95	00	00	00	00	00	00	00	00	00	00	00	00	00	00	00	00	
96-111	00	43	6F	70	79	72	69	67	68	74	20	28	63	29	20	32*	*Copyright
112-127	30*	31*	35*	20	53	65	61	67	61	74	65	20	41	6C	6C	20	notice
128-143	72	69	67	68	74	73	20	72	65	73	65	72	76	65	64	20	

\* Copyright year (changes with actual year).

\*\* SCSI Revision support. See the appropriate SPC release documentation for definitions.

PP 10 = INQUIRY data for an INQUIRY command received on Port A.

30 = INQUIRY data for an INQUIRY command received on Port B.

R# Four ASCII digits representing the last four digits of the product firmware release number.

S# Eight ASCII digits representing the eight digits of the product serial number.

[ ] Bytes 16 through 26 reflect model of drive. The table above shows the hex values for Model ST3840FM0003.

Refer to the values below for the values of bytes 16 through 26 for a particular model:

ST3840FM0023	53	54	33	38	34	30	46	4D	30	30	32	33
ST3840FM0043	53	54	33	38	34	30	46	4D	30	30	34	33
ST3840FM0053	53	54	33	38	34	30	46	4D	30	30	35	33
ST3200FM0023	53	54	33	32	30	30	46	4D	30	30	32	33
ST3200FM0033	53	54	33	32	30	30	46	4D	30	30	33	33
ST3200FM0043	53	54	33	32	30	30	46	4D	30	30	34	33
ST3200FM0063	53	54	33	32	30	30	46	4D	30	30	36	33
ST3200FM0073	53	54	33	32	30	30	46	4D	30	30	37	33
ST1920FM0003	53	54	31	39	32	30	46	4D	30	30	30	33
ST1920FM0023	53	54	31	39	32	30	46	4D	30	30	32	33
ST1920FM0043	53	54	31	39	32	30	46	4D	30	30	34	33
ST1920FM0053	53	54	31	39	32	30	46	4D	30	30	35	33
ST1600FM0003	53	54	31	36	30	30	46	4D	30	30	30	33
ST1600FM0013	53	54	31	36	30	30	46	4D	30	31	31	33
ST1600FM0023	53	54	31	36	30	30	46	4D	30	31	32	33
ST1600FM0073	53	54	31	36	30	30	46	4D	30	31	37	33
ST1600FM0083	53	54	31	36	30	30	46	4D	30	32	38	33
ST960FM0003	53	54	39	36	30	46	4D	30	30	30	33	
ST960FM0013	53	54	39	36	30	46	4D	30	30	31	33	
ST800FM0173	53	54	38	30	30	46	4D	30	31	37	33	

ST800FM0183	53	54	38	30	30	46	4D	30	31	38	33
ST800FM0213	53	54	38	30	30	46	4D	30	32	31	33
ST800FM0233	53	54	38	30	30	46	4D	30	32	33	33
ST800FM0243	53	54	38	30	30	46	4D	30	32	34	33
ST480FM0003	53	54	34	38	30	46	4D	30	30	30	33
ST480FM0013	53	54	34	38	30	46	4D	30	30	31	33
ST400FM0233	53	54	34	30	30	46	4D	30	32	33	33
ST400FM0243	53	54	34	30	30	46	4D	30	32	34	33
ST400FM0293	53	54	34	30	30	46	4D	30	32	39	33
ST400FM0303	53	54	34	30	30	46	4D	30	33	30	33
ST400FM0333	53	54	34	30	30	46	4D	30	33	33	33
ST400FM0343	53	54	34	30	30	46	4D	30	33	34	33
ST200FM0133	53	54	32	30	30	46	4D	30	31	33	33
ST400FM0343	53	54	32	30	30	46	4D	30	31	34	33

### 11.3.2 MODE SENSE data

The MODE SENSE command provides a way for the drive to report its operating parameters to the initiator. The drive maintains four sets of mode parameters:

#### 1. Default values

Default values are hard-coded in the drive firmware stored in flash E-PROM (nonvolatile memory) on the drive's PCB. These default values can be changed only by downloading a complete set of new firmware into the flash E-PROM. An initiator can request and receive from the drive a list of default values and use those in a MODE SELECT command to set up new current and saved values, where the values are changeable.

#### 2. Saved values

Saved values are stored on the drive's media using a MODE SELECT command. Only parameter values that are allowed to be changed can be changed by this method. Parameters in the saved values list that are not changeable by the MODE SELECT command get their values from default values storage.

When power is applied to the drive, it takes saved values from the media and stores them as current values in volatile memory. It is not possible to change the current values (or the saved values) with a MODE SELECT command before the drive is "ready." An attempt to do so results in a "Check Condition" status.

On drives requiring unique saved values, the required unique saved values are stored into the saved values storage location on the media prior to shipping the drive. Some drives may have unique firmware with unique default values also.

On standard OEM drives, the saved values are taken from the default values list and stored into the saved values storage location on the media prior to shipping.

#### 3. Current values

Current values are volatile values being used by the drive to control its operation. A MODE SELECT command can be used to change the values identified as changeable values. Originally, current values are installed from saved or default values after a power on reset, hard reset, or Bus Device Reset message.

#### 4. Changeable values

Changeable values form a bit mask, stored in nonvolatile memory, that dictates which of the current values and saved values can be changed by a MODE SELECT command. A one (1) indicates the value can be changed. A zero (0) indicates the value is not changeable. These are hex numbers representing the changeable values for Mode page 81. Note in columns 5 and 6 (bytes 04 and 05), there is 00h which indicates that in bytes 04 and 05 none of the bits are changeable. Note also that bytes 06, 07, 09, 10, and 11 are not changeable, because those fields are all zeros. In byte 02, hex value FF equates to the binary pattern 11111111. If there is a zero in any bit position in the field, it means that bit is not changeable. Since all of the bits in byte 02 are ones, all of these bits are changeable.

The changeable values list can only be changed by downloading new firmware.

**Note.** Because there are often several different versions of drive control firmware in the total population of drives in the field,



the MODE SENSE values given in the following tables may not exactly match those of some drives.

The following tables list the values of the data bytes returned by the drive in response to the MODE SENSE command pages for SCSI implementation (see the *SAS Interface Manual*).

DEF = Default value. Standard OEM drives are shipped configured this way.

CHG = Changeable bits; indicates if default value is changeable.

## 11.4 Miscellaneous operating features and conditions

Table 20 lists various features and conditions. A “Y” in the support column indicates the feature or condition is supported. An “N” in the support column indicates the feature or condition is not supported.

**Table 20** *Miscellaneous features*

Supported	Feature or condition
N	Automatic contingent allegiance
N	Asynchronous event notification
Y	Segmented caching
N	Zero latency read
Y	Queue tagging (up to 128 queue tags supported)
Y	Deferred error handling
Y	Parameter rounding (controlled by Round bit in MODE SELECT page 0)
N	Reporting actual retry count in Extended Sense bytes 15, 16, and 17

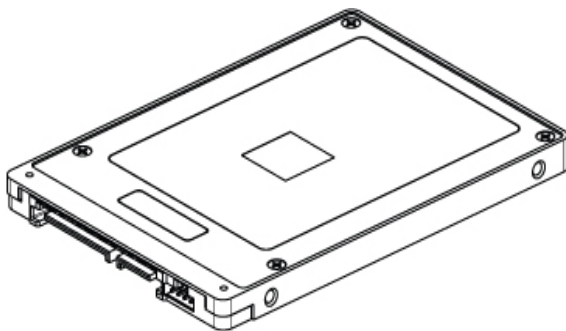
**Table 21** *Miscellaneous status*

Supported	Status
Y	Good
Y	Check condition
Y	Condition met/good
Y	Busy
Y	Reservation conflict
Y	Task set full
N	ACA active
N	ACA active, faulted initiator
N	Task Aborted

### 11.4.1 SAS physical interface

Figure 24 shows the location of the SAS device connector J1. Figures 25 and 26 provide the dimensions of the SAS connector.

Details of the physical, electrical, and logical characteristics are provided within this section. The operational aspects of the Seagate SAS drives are provided in the *SAS Interface Manual*.



**Figure 24.** Physical interface

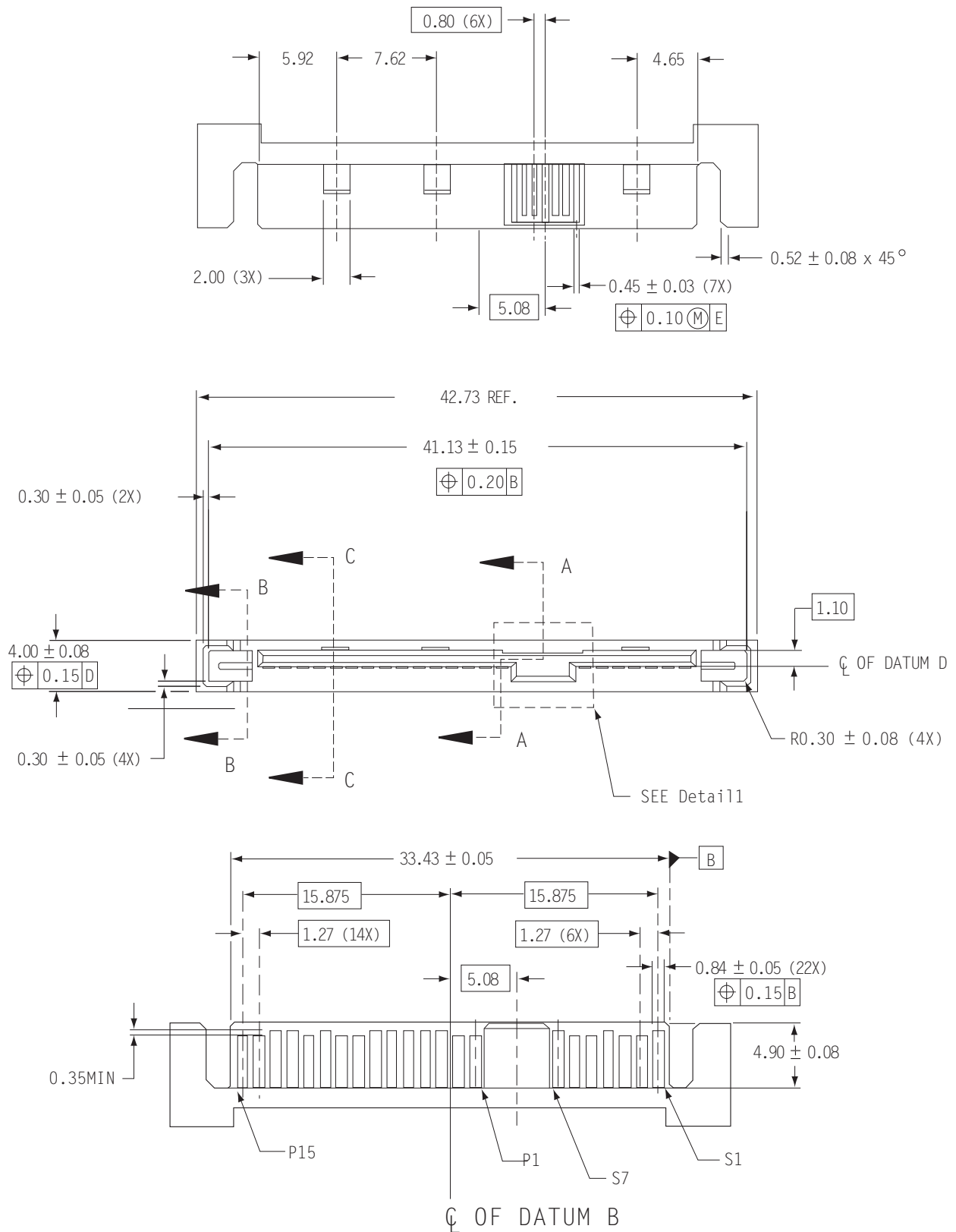


Figure 25. SAS device plug dimensions

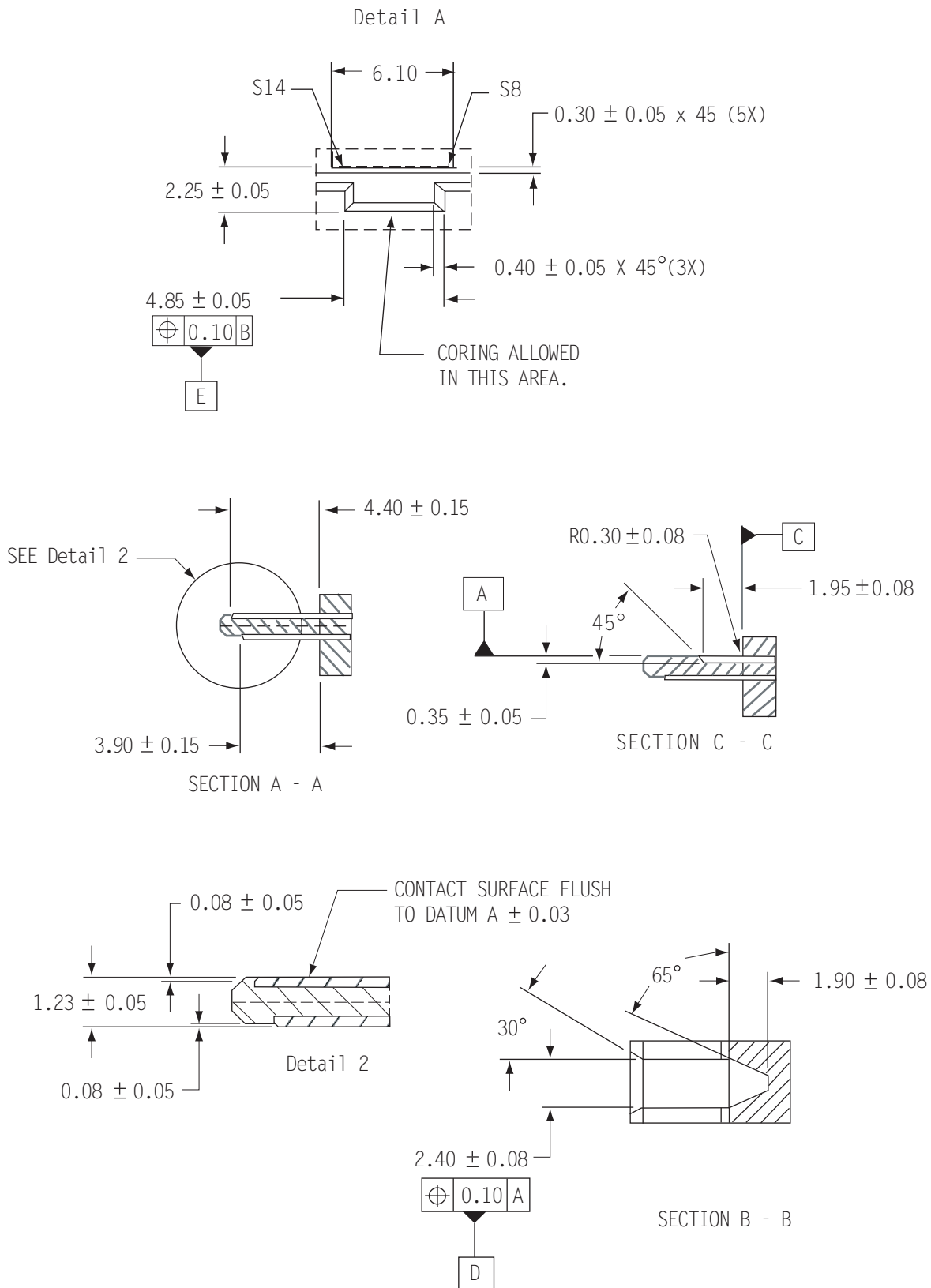


Figure 26. SAS device plug dimensions (detail)

## 11.4.2 Physical characteristics

This section defines physical interface connector.

## 11.4.3 Connector requirements

Contact a preferred connector manufacturer for mating part information. Part numbers for SAS connectors will be provided in a future revision of this publication when production parts are available from major connector manufacturers.

The SAS device connector is illustrated in Figures 25 and 26.

## 11.4.4 Electrical description

SAS drives use the device connector for:

- DC power
- SAS interface
- Activity LED

This connector is designed to either plug directly into a backpanel or accept cables.

## 11.4.5 Pin descriptions

This section provides a pin-out of the SAS device and a description of the functions provided by the pins.

**Table 22 SAS pin descriptions**

Pin	Signal name	Signal type	Pin	Signal name	Signal type
S1	Port A Ground		P1*	Reserved <sup>[1]</sup>	
S2*	+Port A_in	Diff. input pair	P2*	Reserved <sup>[1]</sup>	
S3*	-Port A_in		P3	NC (Vendor specific)	
S4	Port A Ground		P4	Ground	
S5*	-Port A_out	Diff output pair	P5	Ground	
S6*	+Port A_out		P6	Ground	
S7	Port A Ground		P7	5 Volts charge	
S8	Port B Ground		P8*	5 Volts	
S9*	+Port B_in	Diff. input pair	P9*	5 Volts	
S10*	-Port B_in		P10	Ground	
S11	Port B Ground		P11*	Ready LED	Open collector out
S12*	-Port B_out	Diff output pair	P12	Ground	
S13*	+Port B_out		P13	12 Volts charge	
S14	Port B Ground		P14*	12 Volts	
			P15*	12 Volts	

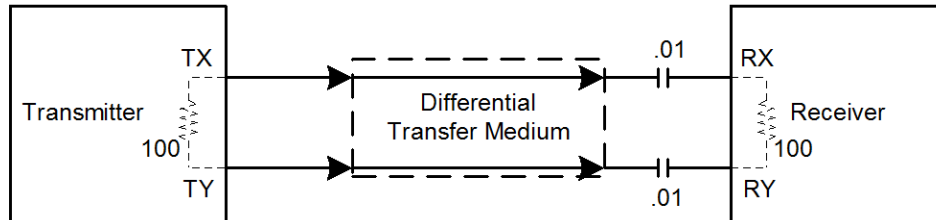
\* - Short pin to support hot plugging

[1] Behind a SAS Drive plug connector, P1 and P2 are only connected to each other.

NC - No connection in the drive.

### 11.4.6 SAS transmitters and receivers

A typical SAS differential copper transmitter and receiver pair is shown in Figure 27. The receiver is AC coupling to eliminate ground shift noise.



**Figure 27.** SAS transmitters and receivers

### 11.4.7 Power

The drive receives power (+5 volts and +12 volts) through the SAS device connector.

Three +12 volt pins provide power to the drive, 2 short and 1 long. The current return for the +12 volt power supply is through the common ground pins. The supply current and return current must be distributed as evenly as possible among the pins.

Three +5 volt pins provide power to the drive, 2 short and 1 long. The current return for the +5 volt power supply is through the common ground pins. The supply current and return current must be distributed as evenly as possible among the pins.

Current to the drive through the long power pins may be limited by the system to reduce inrush current to the drive during hot plugging.

## 11.5 Signal characteristics

This section describes the electrical signal characteristics of the drive's input and output signals. See Table 22 for signal type and signal name information.

### 11.5.1 Ready LED Out

The Ready LED Out signal is driven by the drive as indicated in Table 23.

**Table 23** Ready LED Out conditions

Normal command activity	LED status	
Ready LED Meaning bit mode page 19h	0	1
Drive stopped, not ready, and no activity	Off	Off
Drive stopped, not ready, and activity (command executing)	On	On
Drive started, ready, and no activity	On	Off
Drive started, ready, and activity (command executing)	Off	On
Drive transitioning from not-ready state to ready state or the reverse.	Blinks steadily (50% on and 50% off, 0.5 seconds on and off for 0.5 seconds)	
FORMAT UNIT in progress,	Toggles on/off	

The Ready LED Out signal is designed to pull down the cathode of an LED. The anode is attached to the proper +3.3 volt supply through an appropriate current limiting resistor. The LED and the current limiting resistor are external to the drive. See Table 24 for the output characteristics of the LED drive signals.

**Table 24 LED drive signal**

State	Test condition	Output voltage
LED off, high	$0\text{ V} \leq V_{OH} \leq 3.6\text{ V}$	$-100\ \mu\text{A} < I_{OH} < 100\ \mu\text{A}$
LED on, low	$I_{OL} = 15\text{ mA}$	$0 \leq V_{OL} \leq 0.225\text{ V}$

### 11.5.2 Differential signals

The drive SAS differential signals comply with the intra-enclosure (internal connector) requirements of the SAS standard.

Table 25 defines the general interface characteristics

**Table 25 General interface characteristics**

Characteristic	Units	1.5Gb/s	3.0Gb/s	6.0Gb/s	12.0Gb/s
Bit rate (nominal)	Mbaud	1,500	3,000	6,000	12,000
Unit interval (UI)(nominal)	ps	666.6	333.3	166.6	83.3
Impedance (nominal, differential )	ohm	100	100	100	100
Transmitter transients, maximum	V	$\pm 1.2$	$\pm 1.2$	$\pm 1.2$	$\pm 1.2$
Receiver transients, maximum	V	$\pm 1.2$	$\pm 1.2$	$\pm 1.2$	$\pm 1.2$

### 11.6 SAS-3 Specification compliance

Seagate SAS-3 drives are entirely compatible with the SAS-3 Specification (T10/2212-D).

The most important characteristic of the SAS-3 drive at 6Gb/s is that the receiver is capable of adapting the equalizer to optimize the receive margins. The SAS-3 drive has two types of equalizers:

1. A Decision Feedback Equalizer (DFE) which utilizes the standard SAS-3 training pattern transmitted during the SNW-3 training gap. The DFE circuit can derive an optimal equalization characteristic to compensate for many of the receive losses in the system.
2. A Feed Forward Equalizer (FFE) optimized to provide balanced receive margins over a range of channels bounded by the best and worst case channels as defined by the relevant ANSI standard.

### 11.7 Additional information

Please contact the Seagate representative for SAS electrical details, if required.

For more information about the Phy, Link, Transport, and Applications layers of the SAS interface, refer to the Seagate *SAS Interface Manual*, part number 100293071.

For more information about the SCSI commands used by Seagate SAS drives, refer to the Seagate *SCSI Commands Reference Manual*, part number 100293068.



**Seagate Technology LLC**

*AMERICAS Seagate Technology LLC 10200 South De Anza Boulevard, Cupertino, California 95014, United States, 408-658-1000*

*ASIA/PACIFIC Seagate Singapore International Headquarters Pte. Ltd. 7000 Ang Mo Kio Avenue 5, Singapore 569877, 65-6485-3888*

*EUROPE, MIDDLE EAST AND AFRICA Seagate Technology SAS 16-18 rue du Dôme, 92100 Boulogne-Billancourt, France, 33 1-4186 10 00*

*Publication Number:100773817, Rev. B.*

*April 2016*